# L9969x

# Automotive chip for single and dual H-bridge



life.augmented

PowerSSO24

PowerSSO36

Product status links
L9969S
L9969T
L9969U

Product summary						
Order code	Package	Packing				
L9969S	PSSO24					
L9969T	PSSO36	Tape and reel				
L9969U	F33030					

### Features



- Full path  $R_{DS(on)}$  less than 540 m $\Omega$
- Nominal continuous load current > 3 A
- Operating battery supply voltage 4.5 V to 28 V
- Operating VDD supply voltage 4.5 V to 5.5 V
- All ECU internal pins can withstand up to 18 V
- Output switching frequency up to 20 kHz
- Monitoring of VDD supply voltage including bidirectional switch-off pin NABE
- Overtemperature and short-circuit protection
- Full diagnosis capability
- Output stage with SPI-adjustable current limitation 5-8.6 A in 3 steps (two-point regulation)
- Fast switch-off open-drain input/output
- Current-monitoring with current feedback output signal CF
- Reliable full diagnostic capability
- Settable chip-address via bond-wire configuration on the silicon or E-Fuse
- SPI-interface for configuration and diagnosis
- Error history in diagnosis register
- Two independent enable pins: "NABE" and "DIS"
- Control of power stages by SPI or two input signals, PWM and DIR (configurable via SPI)
- Logic levels 5 V compatible
- Conformity to improved EMC requirements due to smart H-bridge switching
- Full ISO 26262 compliant, ASIL-B (D) systems ready

# **Description**

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L9969S/L9969U and L9969T are single and dual integrated H-bridges for resistive and inductive loads featuring output current direction and supervising functions.

The PowerSSO24 houses one full H-bridge, while the PowerSSO36 houses both two H-bridges that can work in parallel, through independent input driving commands.

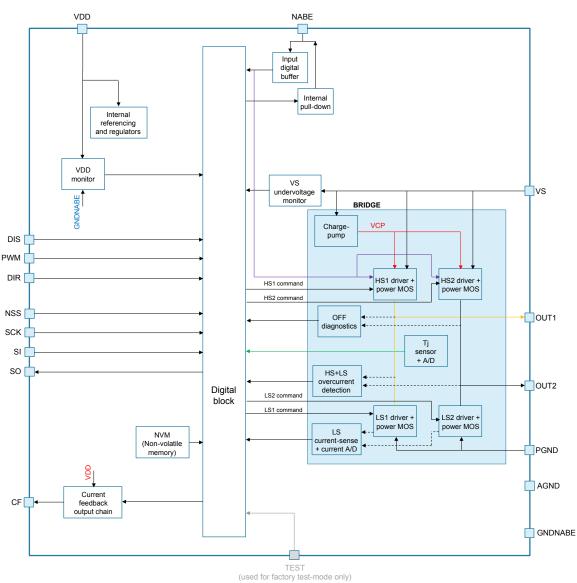
Target application ranges from throttle control actuators to exhaust gas recirculation control valves in automotive domain to a more general use to drive DC and Stepper motors.

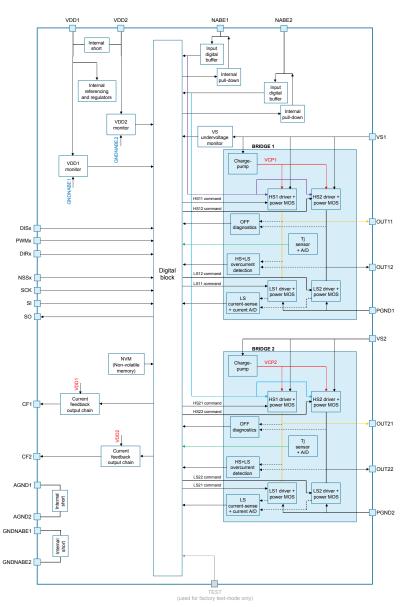


#### Block diagram and pin description 1

#### **Block diagram** 1.1

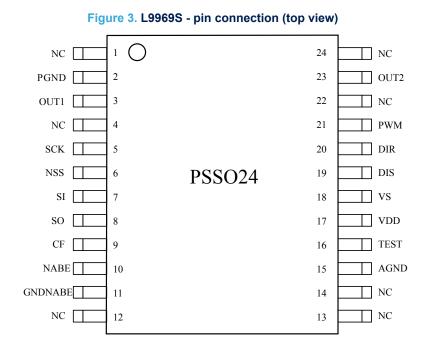
### Figure 1. L9969S/L9969U single bridge IC block diagram



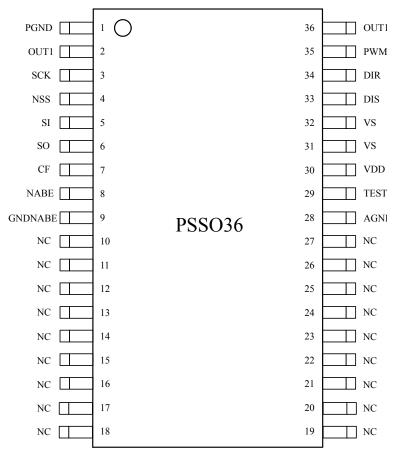


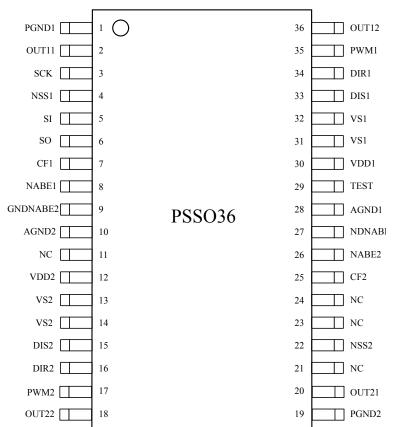


# 1.2 Pin description











### **1.3** Pin definitions and functions

### Table 1. L9969S pin-out

Pin #	Pin name	Description	I/O type	Class
1	NC	Not connected	-	-
2	PGND	Power Ground of H-bridge	G	Global
3	OUT1	Output 1 of H-bridge	0	Global
4	NC	Not connected	-	-
5	SCK	SPI-Clock input of H-bridge	I	Local
6	NSS	SPI-Slave Select input of H-bridge	I	Local
7	SI	SPI-Slave In (data receive) input of H-bridge	I	Local
8	SO	SPI-Slave Out (data transceive) output of H-bridge	0	Local
9	CF	Current feedback of H-bridge. Signal is proportional to the positive current in active LS-transistor of H-bridge.	0	Local
10	NABE	Bidirectional Enable/Disable in-/output. Open-drain output, switched to low at VDD over and undervoltage condition. Low level disables the power stage. (OUT1 and OUT2)	I/O	Local
11	GNDNABE	Reference Ground of VDD-monitoring.	G	Local
12	NC	Not connected	-	-
13	NC	Not connected	-	-

Pin #	Pin name	Description	I/O type	Class
14	NC	Not connected	-	-
15	AGND	Ground connection of H-bridge	G	Local
16	TEST	Factory test-mode activation	I	Local
17	VDD	5 V Supply for H-bridge. Input for VDD monitoring.	Р	Local
18	VS	Supply voltage for H-bridge power stage	Р	Global
19	DIS	Disable input for H-bridge. High-level disables the power stage (OUT1 and OUT2)	I	Local
20	DIR	Direction input of H-bridge.	I	Local
21	PWM	PWM input of H-bridge. Controls the frequency and the duty cycle of the power stage (OUT1 and OUT2).	I	Local
22	NC	Not connected	-	-
23	OUT2	Output 2 of H-bridge.	0	Global
24	NC	Not connected	-	-
-	Exp. PAD	Exposed pad is connected to AGND	-	-

### Legenda: I = Input, O = Output, P = Power Supply, G = Ground, I/O = Input/Output

### Table 2. L9969U pin-out

Pin #	Pin name	Description	I/O type	Class
1	PGND	Power Ground of H-bridge	G	Global
2	OUT1	Output 1 of H-bridge	0	Global
3	SCK	SPI-Clock input	I	Local
4	NSS	SPI-Slave Select input	I	Local
5	SI	SPI-Slave In (data receive) input	I	Local
6	SO	SPI- Slave Out (data transceive) outpu	0	Local
7	CF	Current feedback of H-bridge Signal is proportional to the positive current in active LS-transistor of H-bridge.	0	Local
8	NABE	Bidirectional Enable/Disable in-/output. Open-drain output, switched to low at VDD over and undervoltage condition. Low level disables the power stage. (OUT1 and OUT2)	I/O	Local
9	GNDNABE	Reference Ground for VDD-monitoring of H-bridge	G	Local
10	NC	Not connected.	-	-
11	NC	Not connected.	-	-
12	NC	Not connected.	-	-
13	NC	Not connected.	-	-
14	NC	Not connected.	-	-
15	NC	Not connected.	-	-
16	NC	Not connected.	-	-
17	NC	Not connected.	-	-
18	NC	Not connected.	-	-
19	NC	Not connected.	-	-
20	NC	Not connected.	-	-

Pin #	Pin name	Description	I/O type	Class
21	NC	Not connected.	-	-
22	NC	Not connected.	-	-
23	NC	Not connected.	-	-
24	NC	Not connected.	-	-
25	NC	Not connected.	-	-
26	NC	Not connected.	-	-
27	NC	Not connected.	-	-
28	AGND	Ground connection for H-bridge (Device ground)	G	Local
29	TEST	Factory test-mode activation	I	Local-
30	VDD 5 V Supply for H-bridge. Input for VDD monitoring.		Р	Local
31	VS	Supply voltage of H-bridge power stage	Р	Global
32	VS	Supply voltage of H-bridge power stage	Р	Global
33	DIS	Disable input of H-bridge. High-level disables the power stage (OUT1 and OUT2)	I	Local
34	DIR	Direction input of H-bridge	I	Local
35	PWM	PWM input of H-bridge Controls the frequency and the duty cycle of the power stage (OUT1 and OUT2).	I	Local
36	OUT2	Output 2 of H-bridge	0	Global
-	Exp. PAD	Exposed pad is connected to AGND	-	-

Legenda: I = Input, O = Output, P = Power Supply, G = Ground, I/O = Input/Output

### Table 3. L9969T pin-out

Pin #	Pin name	Description	I/O type	Class
1	PGND1	Power Ground of H-bridge1	G	Global
2	OUT11	Output 1 of H-bridge1		Global
3	SCK	SPI-Clock input	I	Local
4	NSS1	SPI-Slave Select input of H-bridge1	I	Local
5	SI	SPI-Slave In (data receive) input	I	Local
6	SO	SPI-Slave Out (data transceive) output	0	Local
7	CF1	Current feedback for H-bridge1. Signal is proportional to the positive current in active LS-transistor of H-bridge1.	0	Local
8	NABE1	Bidirectional Enable/Disable in-/output. Open-drain output, switched to low at VDDx over and undervoltage condition. Low level disables the power stage. (OUT11 and OUT12)	I/O	Local
9	GNDNABE2	Reference Ground for VDD2-monitoring of H-bridge 2	G	Local
10	AGND2	Ground connection for H-bridge2 (Device ground)	G	Local
11	NC	Not connected.	-	-
12	VDD2	5 V Supply for H-bridge (2). Input for VDD (2) monitoring.	Р	Local
13	VS2	Supply voltage for H-bridge2 power stage	Р	Global
14	VS2	Supply voltage for H-bridge2 power stage	Р	Global
15	DIS2	Disable input for H-bridge2.	I	Local

Pin #	Pin name	Description	I/O type	Class
		High-level disables the power stage (OUT21 and OUT22)		
16	DIR2	Direction input of H-bridge2.	I	Local
17	PWM2	PWM input of H-bridge2. Controls the frequency and the duty cycle of the power stage (OUT21 and OUT22).	I	Local
18	OUT22	Output 2 of H-bridge2	0	Global
19	PGND2	Power ground connection for H-bridge2.	G	Global
20	OUT21	Output 1 of H-bridge2	0	Global
21	NC	not connected.	-	-
22	NSS2	SPI-Slave Select input of H-bridge2.	I	Local
23	NC not connected.		-	-
24	NC	not connected.	-	-
25	5 CF2 Current feedback of H-bridge2. Signal is proportional to the positive current in active LS-transistor of H-bridge2.		0	Local
26	Bidirectional Enable/Disable in-/output.           NABE2         Open-drain output, switched to low at VDDx over and undervoltage condition.		I/O	Local
27	GNDNABE1	Low level disables the power stage. (OUT21 and OUT22) Reference Ground of VDD1-monitoring of H-bridge 1	G	Local
28	AGND1	Ground connection for H-bridge1 (Device ground)	G	Local
29	TEST	Factory test-mode activation		Local
30	VDD1	5 V Supply for H-bridge1. Input for VDD1 monitoring.	Р	Local
31	VS1	Supply voltage of H-bridge1 power stage	Р	Global
32	VS1	Supply voltage of H-bridge1 power stage	Р	Global
33	DIS1	Disable input of H-bridge1. High-level disables the power stage (OUT11 and OUT12)	I	Local
34	DIR1	Direction input of H-bridge1.	I	Local
35	PWM1       PWM input of H-bridge1.         Controls the frequency and the duty cycle of the power stage (Out11 and Out 12).		I	Local
36	OUT12	Output 2 of H-bridge1.	0	Global
-	Exp. PAD	Exposed pad is connected to AGNDx	-	-
		1		

Legenda: I = Input, O = Output, P = Power Supply, G = Ground, I/O = Input/Output



# 2 Electrical specifications

# 2.1 Operating range

Within the operating range the part operates as specified and without parameter deviations. The device may not operate properly if maximum operating conditions are exceeded.

Once taken beyond the operative ratings and returned back within, the part will recover with no damage or degradation.

The voltages are referred to ground, and currents are assumed positive, when the current flows into the pin.

Symbol	Parameter	Condition	Min	Тур	Мах	Unit
VS_or	VS operative range	-	5	-	18	V
VDD_or	VDD operative range	-	4.5	-	5.2	V
Тј	Junction temperature	-	-40	-	150	°C
V <sub>VS_slew</sub>	Maximum slew rate on $V_S$ (no change of parameters)	VDD = 5 V IOUT = 3 A V <sub>S</sub> = 6 V, 10 V, 14 V, 18 V	-	-	20	V/µs
V <sub>GND_DELTA</sub>	Voltage differences between GND pins	-	-0.3	-	0.3	V

### Table 4. Operating range

# 2.2 Thermal data

### Table 5. Temperature data

Symbol	Description	Min	Тур	Max	Unit
T <sub>amb</sub>	Operating temperature (ECU environment)	-40	-	125	°C
Tj	Operating junction temperature	-40	-	150	°C
T <sub>stg</sub>	Storage temperature	-55	-	150	°C
R <sub>Th j-amb</sub>	Thermal resistance junction-to-ambient for L9969T PSSO36	-	23.9	-	°C/W
R <sub>Th j-amb</sub>	Thermal resistance junction-to-ambient for L9969S PSSO36	-	25.4	-	°C/W
R <sub>Th j-amb</sub>	Thermal resistance junction-to-ambient for L9969S PSSO24	-	25.4	-	°C/W
R Th j-case_bot	Thermal resistance junction-to-case bottom for L9969T PSSO36	-	1	-	°C/W
R Th j-case_bot	Thermal resistance junction-to-case bottom for L9969S PSSO36	-	2	-	°C/W
R Th j-case_bot	Thermal resistance junction-to-case bottom for L9969S PSSO24	-	2	-	°C/W

### 2.2.1 Temperature and load profile

The IC is designed for temperature profile that is transferred for  $T_i = 175$  °C at t  $\ge 1500$  h.



# 2.3 Absolute maximum ratings

### 2.3.1 Supply voltage

There is no special sequence to switch on the different voltages (V<sub>S</sub>, VDD and voltages on any input pins).

Even if there is only  $V_S$  applied, signals on the internal inputs or outputs, even up to 18 V, must not result in any kind of faulty reaction of the H-bridge or in a destruction of the H-bridge.

Symbol	Parameter	Condition	Min	Тур	Мах	Unit
N		VDD = 0 V	4.0		00	
V <sub>VS</sub>	VS Static destruction proof	VDD = 5 V	-1.0	-	Max         28         40         5.0         18         Vvs + CP voltage         VS + Vf         VS + Vf         10         18         60	V
M		VDD = 0 V	1.0	_	40	V
V <sub>VS</sub>	VS Dynamic destruction proof; see load dump pulse	VDD = 5 V	-1.0	-	40	V
I <sub>VS,INV</sub>	Dynamic destruction proof t < 0.25 s	VDD = 0 V			5.0	Α
VS,INV	Bynamic destruction proof t < 0.25 s	VDD = 5 V	-	-	5.0	
		V <sub>S</sub> = 0 V	0.5		40	
V <sub>VDD</sub>	VDD Static destruction proof	V <sub>S</sub> = 18 V	-0.5	-	18	V
		VDD = 0 V			V <sub>VS</sub> + CP	
V <sub>cp</sub>	Charge Pump Destruction proof	VDD = 5 V	-	-		V
		V <sub>S</sub> = 28 V				
	Vout static destruction proof	VDD = 0 V		) –	VS	
V <sub>Outx</sub>		VDD = 5 V	-1.0		+Vf	V
		I <sub>x</sub> = 3 A				
		V <sub>S</sub> = 40 V				
	V <sub>out</sub> dynamic destruction proof, see load dump pulse)	VDD = 0 V			VS	
V <sub>Outx</sub>	load condition: 0.8 mH to 1 mH, PWM $f_{max}$ = 20 kHz)	VDD = 5 V	-		V <sub>VS</sub> + CP voltage VS +Vf VS +Vf 10	V
		I <sub>x</sub> = 10 A				
		VOUTx ≤ V <sub>S</sub> + Vf				
I <sub>Outx</sub>	lout dynamic destruction proof t < 0.5 s (load condition: 0.8 mH to 1 mH, PWM f <sub>max</sub> = 20 kHz)	VDD = 0 V	-	-	10	A
		VDD = 5 V				
		V <sub>S</sub> = 0 V				
		V <sub>S</sub> = 18 V				
Vx	Static destruction proof for internal pins	VDD = 0 V	-0.5	-	18	V
		VDD = 5 V				
		VDD = 18 V				
		VDD = 5 V				
V <sub>VS_slew</sub>	Maximum slew rate on $V_S$ (no destruction and no change of parameters)	IOUT = 3 A	-	-	60	V/µs
	onange of parameters)	$V_{\rm S}$ = 6 V, 10 V, 14 V, 18 V		$5 - 18$ $- V_{VS} + CP_{Voltage}$ $- VS_{+Vf}$ $- VS_{+Vf}$ $- 10$ $5 - 18$		

### Table 6. Absolute Maximum Ratings

Note:

Vf is the voltage drop (by the defined current) over the body diode of the H-bridge driver.



# 2.4 Quiescent current consumption

L9969 can guarantee quiescent current values below defined values. Table 7 reports all cases of interest, varying from disabled bridge, to bridge driven ON at different PWM frequencies, but without any output current to loads.  $5 \text{ V} < \text{VBATT} < 18 \text{ V}, 4.5 \text{ V} < \text{VDD} < 5.5 \text{ V}, T_J = -40 ^{\circ}\text{C}$  to 150  $^{\circ}\text{C}$ , unless otherwise specified.

Symbol	Parameter	Condition	Min	Тур	Max	Unit
		5 V < V <sub>S</sub> < 18 V				
$I_{VS}$	Quiescent current consumption	Bridge disabled	-	-	15	mA
		VDD = 5 V				
		V <sub>S</sub> = 14 V				
I <sub>VS</sub>	Stand-by current consumption	Bridge disabled	10	-	100	μA
		VDD = 0 V				
		5 V < V <sub>S</sub> < 18 V				
h in	Quiescent current consumption	f <sub>OUT</sub> = 2 kHz		-	18	mA
I <sub>VS</sub>		VDD = 5 V	-			IIIA
		IOUT = 0 A				
		5 V < V <sub>S</sub> < 18 V		-		
h.e.	Quiescent current concurration	f <sub>OUT</sub> = 10 kHz			21	
I <sub>VS</sub>	Quiescent current consumption	VDD = 5V	-		21	mA
		IOUT = 0 A				
		V <sub>S</sub> = 28 V				
		f <sub>OUT</sub> = 10 kHz		-	0.5	mA
I <sub>VS</sub>	Quiescent current consumption	VDD = 5 V	-		25	
		IOUT = 0 A				

### Table 7. Quiescent current consumption

# **2.5 ESD protection**

### Table 8. ESD protection

ltem	Parameter	Condition	Min	Тур	Max	Unit
All pins	-	НВМ	-2	-	2	kV
All pins	-	CDM (values for corner pins in brackets)	-500/(-750)	-	500/(750)	V
Pins to connector <sup>(1)</sup>	-	НВМ	-4	-	4	kV

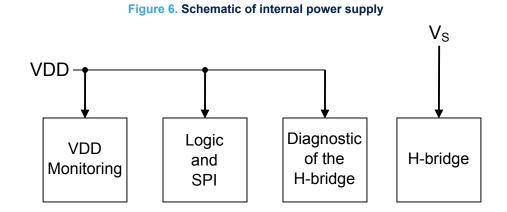
1. Pins are all GND connected together.



# 2.6 Power Supply

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Figure 6 shows the connections between power supplies and L9969 internal blocks.



### Table 9. VDD current absorption

Symbol	Parameter	Condition	Min	Тур	Мах	Unit
		VDD = 4.5 V to 5.5 V				
		DIS = VDD				
IVDD_SINGLE_OFF	Single bridge IC VDD supply current, bridge disabled	NABE = 0 V	-	-	11	mA
		R <sub>CF</sub> = 5.1 kΩ				
		CL4			11 m/ 13.4 m/ 18.3 m/	
		VDD = 4.5 V to 5.5 V	.5 V - /			
		DIS = 0 V				
IVDD_SINGLE_ON_3A		NABE = VDD				
	Single bridge IC VDD supply current, bridge enabled with 3 A load	R <sub>CF</sub> = 5.1 kΩ	-	-	13.4	mA
		PWM = DIR = 0 V	M = DIR = 0 V			
		I <sub>OUT</sub> = 3 A				
		CL4				
		VDDx = 4.5 V to 5.5 V	5 V			
		DISx = VDD				
IVDD_TWIN_OFF	Twin bridge IC VDD supply current (VDD1 + VDD2), both bridges disabled	NABEx = 0 V	-	-	18.3	mA
		R <sub>CFx</sub> = 5.1 kΩ				
		CL4				
		VDDx = 4.5 V to 5.5 V				
		DISx=0V			18.3 r	
		NABEx = VDD				
IVDD_TWIN_ON_3A	Twin bridge IC VDD supply current (VDD1 + VDD2), both bridges enabled with 3 A load	R <sub>CFx</sub> = 5.1 kΩ	-	-	23.1	mA
		PWMx = DIRx = 0 V				
		I <sub>OUTx2</sub> = 3 A				
		CL4				



### 2.6.1 Power-ON reset

VDD is internally monitored, to keep the output stages in tristate in case VDD is incorrect.

Two internal monitoring/resetting sources are implemented:

- The internal reset function in the H-bridge if VDD is decreasing down to V<sub>DD\_RES</sub>. That function resets the SPI registers, switches the output stages to tristate and switches NABE to low.
- The internal VDD monitoring, that is working, if the VDD > VDD\_POR for longer than tPOR. In this case, the SPI is working; the VDD monitoring is active and sets the SPI registers, switches the output stages to tristate and switches NABE to low, if VDD is incorrect. In any cases, after a Power-ON Reset, the H-bridge is completely functional again, but the outputs are disabled. They can only be enabled by ENDISR.

5 V < VBATT < 18 V, T<sub>J</sub>= -40 °C to 150 °C, unless otherwise specified.

### Table 10. VDD monitoring thresholds

Symbol	Parameter	Condition	Min	Тур	Max	Unit
V <sub>DD_RES</sub>	VDD Undervoltage Threshold (VDD: 'H' $\rightarrow$ 'L') Below this threshold the device is in reset state, all registers are cleared.	-	3.3	3.6	3.9	V
V <sub>DD_POR</sub>	Power On Reset Threshold (VDD: 'L' $\rightarrow$ 'H') Below this threshold the device is in reset state, all registers are cleared. The device starts operation (VDD monitoring forces stages off) not later than $t_{POR}$ , when VDD is rising above this threshold. SPI is functional.	-	3.5	3.8	4.1	V
t <sub>POR</sub>	Power On Reset Extension Time	-	-	-	1000	μs

### 2.6.2 NABE and VDD monitoring

### 2.6.2.1 General functions of VDD monitoring

 $V_{DD}$  is measured with reference to pin GND<sub>ABE</sub>. Inside the H-bridge, GND<sub>ABE</sub> is routed separately to avoid internal cross talking from power lines.

The state of V<sub>DD</sub> monitoring is stored in STATCON\_REG and is read/write via SPI.

V<sub>DD</sub> monitoring detects faulty supply voltages at V<sub>DD</sub>. It disables the output stages but does not reset registers DIA\_REG1, DIA\_REG2, CONFIG\_REG or STATCON\_REG.

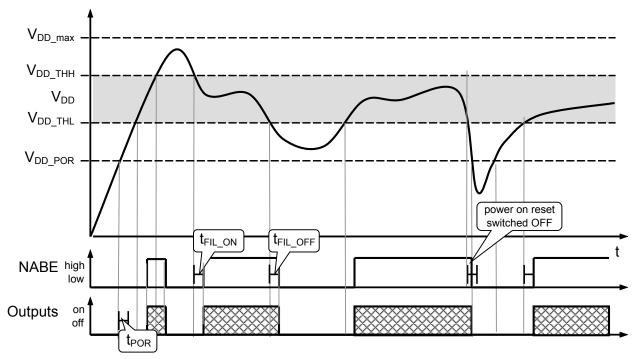
In case of  $V_{DD}$  failure, the output stages are switched off, even if the voltage at pin NABE is a high level, for example because of an external short circuit to  $V_{DD}$  or to the battery voltage (up to 18 V).

OUT1 and OUT2 cannot be switched on in over or undevoltage condition at  $V_{DD}$ .

POR (V<sub>DD</sub> < V<sub>DD</sub> <sub>RES</sub>) switches off all output stages without delay.

Detailed information (differentiation of over and undervoltage detection) is possible by SPI interface.





### 2.6.2.2 VDD undervoltage

If the voltage between pins  $V_{DD}$  and  $GND_{ABE}$  is below the lower  $V_{DD}$ -monitoring threshold ( $V_{DD_THL}$ ), the output stages are switched off after a filtering time ( $t_{FIL_OFF}$ ) and an active low signal is generated at the bi-directional pin NABE. After a transition from an undervoltage to a regular voltage between pins  $V_{DD}$  and  $GND_{ABE}$ , the signal at pin NABE is (automatically) set high again once the filtering time ( $t_{FIL_ON}$ ) has expired. Writing new information to configuration registers is possible.

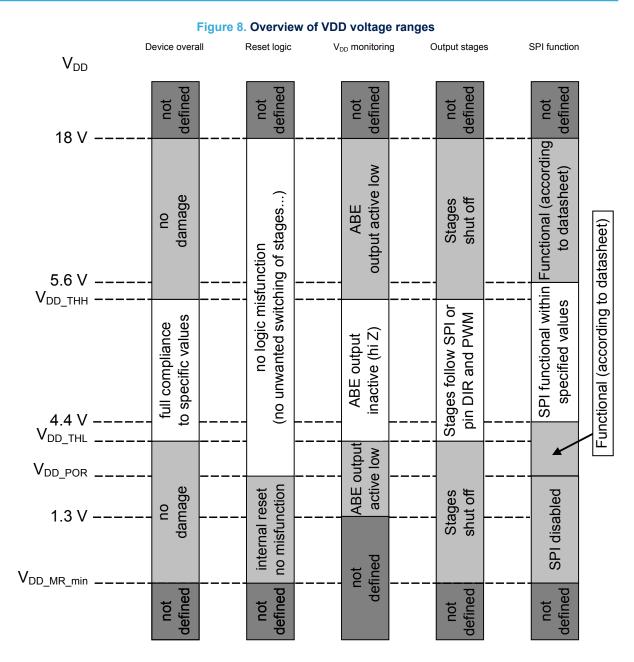
If VDD falls below the power-on-reset supply voltage ( $V_{DD_RES}$ ) all stages are switched off and NABE is switched active low. When VDD is rising above the power-on-reset supply voltage threshold ( $V_{DD_POR}$ ), the ASIC will remain in POR until a time  $t_{POR}$  is run out, then all registers will be reset to their respective default state (all registers cleared to default).

### 2.6.2.3 VDD overvoltage

If the voltage between pins  $V_{DD}$  and  $GND_{ABE}$  is above the upper  $V_{DD}$ -monitoring threshold ( $V_{DD_THH}$ ), all output stages are switched off after a filtering time ( $t_{FIL_OFF}$ ) and an active low signal is generated at the bi-directional pin NABE.

After a transition from an overvoltage to a regular voltage between pins  $V_{DD}$  and  $GND_{ABE}$ , the behavior of the NABE level and the output stages depend on the configuration of the bit CONFIG0 of STATCON\_REG:

- 1: NABE is latched and the outputs remain off. A return to normal operation is only possible with power-on reset or by changing the bit STATCON\_REG.CONFIG0 via SPI  $\rightarrow$  0.
- 0: NABE is inactive after VDD returned to its regular operating voltage and the filtering time has expired. The power stages are enabled again automatically. Writing new information to configure registers is possible.



### 2.6.2.4 Behavior on pin NABE in case of external short circuit

In case a short circuit on the PCB pulls both pins NABE and  $V_{DD}$  for example, to the battery voltage (max. 18 V), the internal power-stage at pin NABE is designed in such a way that the H-bridge is not damaged, in case NABE is pulled-down internally to GND, even though an external battery voltage is applied low-ohmic to pin NABE. The internal power-stage sustains such short-circuit for a few hours.

### 2.6.2.5 NABE Pin

NABE is a bidirectional pin (input and output). As an input function, all output power-stages are permanently switched off if an external low signal is applied to pin NABE. NABE output is realized as an open drain low side switch. During a  $V_{DD}$  over-voltage (above  $V_{DD_THH}$ ) or undervoltage (below  $V_{DD_THL}$ ), the pin is pulled to GND (logic low). Refer also to Section 2.6.2.4 Behavior on pin NABE in case of external short circuit in case of an external short circuit at pin NABE.

The NABE-Pin is made redundant to the DIS-Pin to reach the ISO26262 Safety Goals. The NABE goes directly to the Gate-Driver of the Bridge.

The default signal level of "NABE" (for example in case of ECU initialization) is low-level with integrated pull down-current source.



A low logic level at "NABE" and/or a high logic level at "DIS" switch off all output stages. In this case the access to the SPI is possible and the bit NABE\_DIS in the DIA\_REG1 is set to low.

Two separate pins are provided for NABE and DIS. For safety reasons, these signals are routed separately and ideally with a certain distance from each other on the silicon.

### 2.6.2.6 Testing of VDD monitoring

VDD Monitoring cannot be switched off. The output stages are switched off by V<sub>DD</sub> monitoring if under or overvoltage on V<sub>DD</sub> is detected. Testing of V<sub>DD</sub> monitoring is possible via SPI.

### Testing of upper thresholds:

By writing STATCON\_REG, bit CONFIG2 = 0, the VDD test mode is activated.

If STATCON\_REG, bit CONFIG1 = 0, the upper VDD test threshold is lowered (overvoltage threshold is reduced to  $V_{\text{TEST THH}}$ ).

As a result, STATCON REG, bit STATUS0 = 0 and DIA REG1, bit NABE DIS = 0.

Overvoltage is reported and pin NABE is pulled low.

Once the test routine is ended (CONFIG2 = 1) or the upper VDD test threshold is reset to its standard value, STATUS0=1 (no overvoltage anymore) and NABE\_DIS =1. Pin NABE is pulled high.

The same test routine can be performed with STATCON\_REG, bit CONFIG0 = 1 (latching of overvoltage condition). In that case, ending the test routine will not automatically reset bit NABE\_DIS and pin NABE.

### Testing of lower thresholds:

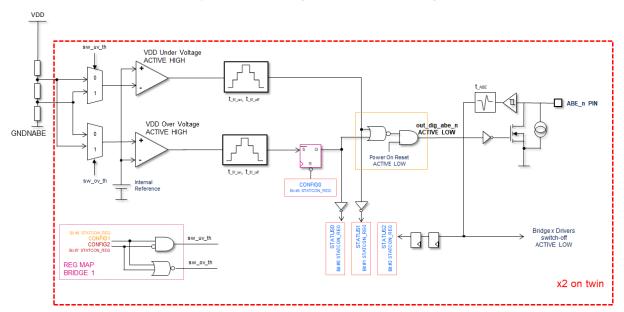
By writing STATCON\_REG, bit CONFIG2 = 0, the VDD test mode is activated.

If STATCON\_REG, bit CONFIG1 = 1, the lower VDD test threshold is lifted (undervoltage threshold is increased to V<sub>TEST\_THL</sub>).

As a result, STATCON\_REG, bit STATUS1 = 0 and DIA\_REG1, bit NABE\_DIS = 0.

Undervoltage is reported and pin NABE is pulled low.

Once the test routine is ended (CONFIG2 = 1) or the lower VDD test threshold is reset to its standard value, STATUS1=1 (no undervoltage anymore) and NABE\_DIS =1. Pin NABE is pulled high.



### Figure 9. Circuit diagram of VDD monitoring

Table 1	1.	VDD	Monitoring	parameters
---------	----	-----	------------	------------

Symbol	Parameter	Condition	Min	Тур	Max	Unit
V <sub>DD</sub>	VDD voltage range at which monitoring circuit shows defined behavior on pin NABE	-	V <sub>DD_POR</sub>	-	18	V
V <sub>DD_THL</sub>	VDD Undervoltage threshold	-	4.2	-	4.4	V
V <sub>DD_THH</sub>	VDD Overvoltage threshold	-	5.25	-	5.5	V
t <sub>FIL_OFF</sub>	Filtering time before switching off, when VDD voltage goes out of thresholds	-	60	-	135	μs
t <sub>FIL_ON</sub>	Filtering time before switching on, when VDD comes back inside thresholds	-	60	-	135	μs
V <sub>TEST_THL</sub>	VDD Undervoltage threshold during VDD Monitoring test	-	5.25	-	5.5	V
V <sub>TEST_THH</sub>	VDD Overvoltage threshold during VDD Monitoring test	-	4.2	-	4.4	V
$V_{DD\_slew}$	Maximum slew rate on VDD without any change of parameters of VDD monitoring	-	500	-	-	mV/ μs
$\Delta V_{DD_{THx}}$	Change of VDD_THH or VDD_THL, in case of inverse current on ${\sf V}_{\sf S}$	-	-0.1	-	0.1	V
V <sub>ABE_INL</sub>	NABE input low level	-	-0.3	-	1.65	V
V <sub>ABE_INH</sub>	NABE input high level	-	3.15	-	18	V
VABE_INHYS	NABE input hysteresis	-	0.15	-	1.0	V
I <sub>ABE_IN</sub>	NABE input current	VABE = 18 V	20	-	70	μA
I <sub>ABE_IN</sub>	NABE input current	VABE = 5 V	20	40	60	μA
I <sub>ABE_IN</sub>	NABE input current	0 V < VABE < 1,5 V	0	-	60	μA
V <sub>ABE_OUTL</sub>	NABE output voltage when VDD below THL	0 V < VDD < VDD_THL IABE_OUTL < 2.5 mA	0.0	-	1.0	v
V <sub>ABE_OUTL</sub>	NABE output voltage when VDD above THH	VDD_THH < VDD < 18 V IABE_OUTL < 7.5 mA	0.0	-	1.2	v
V <sub>ABE_OUTL</sub>	Passive output low voltage	Pull down current source to GND, no load Measure voltage at NABE (if NABE is high impedance).	0.0	-	1.0	v
t <sub>ABE</sub>	NABE pulse width (minimum width required for setting/resetting SPI bits or diagnostic information	-	0.5	1	1.5	μs
$\Delta I_{ABE}$	Change of input current of NABE output pin in case of inverse current on $V_S$	-	-100	-	100	μA

# 3 Functional description

### 3.1 Description of external interfaces

- Voltage supply Vs can be connected directly to the battery voltage via a relay (for example the main relay in an engine control system). Otherwise an additional external inverse voltage protection is necessary.
- The load at the outputs is connected between both outputs (OUT1 and OUT2) in H-bridge mode.
- The ASIC has two inputs controlling the current through the H-bridge: DIR controls the direction of the current (DIR = 0 → Current flows from OUT1 → OUT2; DIR = 1 → Current flows from OUT2 → OUT1) and PWM controls the magnitude of the current (duty cycle 0% → no current ... duty cycle 100% → maximum current).

### 3.2 Functional behavior in detail

All parameters are defined at (unless otherwise specified):

- 4.5 V < VDD < 5.5 V
- VUF < V<sub>S</sub> < 28 V (power stages active)</p>
- 0 V < V<sub>S</sub> < VUF (power stages inactive)</li>
- -40 °C < T<sub>J</sub> < 150 °C
- The HBR can withstand a V<sub>S</sub> of 40 V for load dump pulse (see Section 6 Load dump pulse)
- It is recommended to perform the necessary adjustments at high temperature
- All voltages refer to AGND

### 3.2.1 Power stages

L9969 provides a full H-bridge power stage, consisting of two half bridges, which are intended to be used mainly for the control of DC motors.

The most critical loads are throttle-control actuators with the following electrical characteristics: inductance 0.8 mH to 1.0 mH, resistance 1.2  $\Omega$  to 1.8  $\Omega$  at room temperature, PWM-frequency f<sub>min</sub> = 1 Hz and f<sub>max</sub> = 20 kHz. 5 V < VBATT < 18 V, 4.5 V < VDD < 5.5 V, T<sub>J</sub>= -40 °C to 150 °C, unless otherwise specified.

Symbol	Parameter	Condition	Min	Тур	Max	Unit
		I <sub>OUT</sub> = 3 A				
R <sub>OUT-GND</sub>	Rds_ON resistance low side	10 V < V <sub>S</sub> < 28 V	-	-	225	mΩ
	ROUT-UB     Rds_ON resistance high side     1	Max. values at T <sub>j</sub> = 150 °C				
		I <sub>OUT</sub> = 3 A				
R <sub>OUT-UB</sub>	Rds_ON resistance high side	10 V < V <sub>S</sub> < 28 V	-	-	315	mΩ
Rout-ub       Rds_ON resistance high side       I         Image: Constraint of the state leakage current H-bridge disabled by short circuit       Image: Constraint of the state leakage current H-bridge disabled by short circuit	Max. values at T <sub>j</sub> = 150 $^{\circ}$ C					
	OFF State leakage current H-bridge disabled by short circuit	V <sub>S</sub> = 13 V	-200		200	
lleak	detection; this is the current of one stage	OUTx = 0 V or $V_S$	-200	-	200	μA
		V <sub>S</sub> = 13 V	200		000	
leak	OFF State leakage current VDD below VDD_RES	$OUTx = 0 V \text{ or } V_S$	-200	-	800	μA

### Table 12. Power stages parameters

### 3.2.2 Inverse current on V<sub>S</sub>

Inverse currents flow out of  $V_S$ . An inverse current with maximum 5 A decreasing during a maximum period of 250 ms does not lead to any destruction of the H-bridge ASIC. After exposure to such an inverse current, the full functionality of the device is guaranteed (according to the product target specification).

Information is needed about the behavior of the inputs and outputs during inverse current. Furthermore, information is needed on the reliability of information stored in internal registers during inverse current.

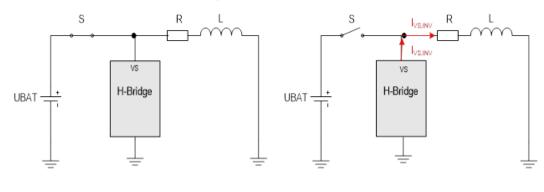


Figure 10. Inverse current

normal operation

Inverse current after UBAT switch off

5 V < VBATT < 18 V, 4.5 V < VDD < 5.5 V, T\_J= -40  $^\circ\text{C}$  to 150  $^\circ\text{C},$  unless otherwise specified.

### Table 13. Inverse Current

Symbol	Parameter	Condition	Min	Тур	Мах	Unit
I <sub>VS,INV</sub>	Inverse Current	250 ms	-	-	5	А
$V_{VS\_slew\_inv}$	Maximum slew rate during inverse current	-	-5	-	-	V/µs

### 3.2.3 Reverse current

Reverse current is different from inverse Current. It is the current flowing in the load during the passive freewheeling phase, and passing through the low-side body diode, as soon as the high-side of the same branch is switched OFF.

To reduce internal power losses, the free-wheeling is designed in such a way that, after some period of time, the free-wheel diode is actively short-cut by the transistor channel (beginning the so-called active free-wheeling).  $5 \text{ V} < \text{VBATT} < 18 \text{ V}, 4.5 \text{ V} < \text{VDD} < 5.5 \text{ V}, T_J = -40 \text{ }^{\circ}\text{C}$  to 150  $^{\circ}\text{C}$ , unless otherwise specified.

### Table 14. Reverse current

Symbol	Parameter	Condition	Min	Тур	Max	Unit
U <sub>D</sub>	Free-wheel diode forward voltage	I <sub>OUT</sub> = 3 A	-	-	2	V
t <sub>rr</sub>	Free-wheel diode reverse recovery time	-	-	-	100	ns

If the H-bridge is in internal current limitation or in thermal current reduction mode, the above-mentioned shortcircuiting of the free-wheeling diode is enabled or disabled according to the status of the free-wheeling bit in the SPI register: CONFIG\_REG.FW = 1 (short-cut enabled - active free wheeling) or CONFIG\_REG.FW = 0 (short-cut disabled – passive free wheeling).



### 3.2.4 Power stage switching behavior

Here below (see the Table 15) the possible combinations parallel inputs/driver outputs.

PWM	DIR	OUT1	OUT2	Remark
L	L	L	L	No active current flow into the load
L	Н	L	L	No active current flow into the load
Н	L	Н	L	A current flows from HS1 toward LS2
Н	н	L	Н	A current flows from HS2 toward LS1

### Table 15. Parallel inputs combinations and output states

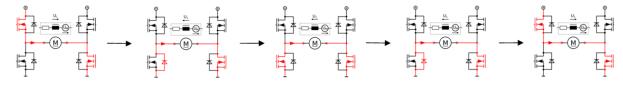
Note: HSx stands for high-side transistor of half-bridge x; LSx stands for low-side transistor of half-bridge x.

### 3.2.4.1 Switching sequence during regular operation

The switching sequence during a regular pulsed width modulation operation is shown in the figure below and is made of 5 steps:

- 1. The connected load is powered, for example, via HSS1 and LSS2.
- 2. This is the transition between the powering and the active free-wheeling phase. During this short time where HSS1 is getting non-conductive and LSS1 has not started conducting yet, a passive free-wheeling via the bulk diode of LSS1 takes place.
- 3. This is the active free-wheeling. In this step LSS1 gets conductive.
- 4. This is the transition between the active free-wheeling and the powering phase. Similarly to the 2<sup>nd</sup> step, LSS1 is getting non-conductive and HSS1 has not started conducting yet. A passive free-wheeling via the bulk diode of LSS1 takes place.
- 5. See 1<sup>st</sup> step.





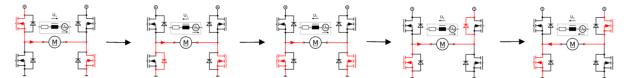
During a regular operation, there is always one half-bridge responsible for the pulsation (in the above example the half-bridge made of HSS1 and LSS1) and one static half-bride (in the above example the half-bridge made of HSS2 and LSS2). As showed in the above example, the LSS of the static half-bridge remains conducting over the complete period whereas the HSS of the static half-bridge is unused.

### 3.2.4.2 Switching sequence during change of direction

The switching sequence during a change of direction is shown in the figure below and is made of 5 steps:

- 1. The connected load is powered, for example, via HSS1 and LSS2.
- 2. This is the transition between the powering and the active free-wheeling phase. During this short time where HSS1 is getting non-conductive and LSS1 has not started conducting yet, a passive free-wheeling via the bulk diode of LSS1 takes place.
- 3. This is the active free-wheeling. In this step LSS1 gets conductive.
- 4. In this step, the change of direction is starting. Now, LSS2 is getting non-conductive but HSS2 has not started conducting yet. The induced current resulting from the back electromotive force (back-EMF) is still flowing from the left to the right. The current is flowing via the bulk diode of HSS2, the external capacitor and back via LSS1.
- 5. In this step, HSS2 is getting conductive. The connected load is finally powered in the opposite direction via HSS2 and LSS1.

### Figure 12. Switching sequence during change of direction



### 3.2.4.3 **Power stage switching parameters**

Parameters valid at V<sub>S</sub> in the range of (8 V...18 V),  $I_{OUT}$  = 3 A. T = -40 °C to 150 °C, unless otherwise specified;  $C_{OUTxy}$  = 10 nF connected during all the tests below.

Symbol Parameter Condition Min Тур Max Unit Output HS ON delay PWM or DIR 50%  $\rightarrow$  OUT 20% SR = 00 15 t<sub>don00\_dcm0</sub> μs DCmatching = 0 Output HS ON delay PWM or DIR 50%  $\rightarrow$  OUT 20% SR = 01 10 t<sub>don01\_dcm0</sub> \_ μs DCmatching = 0 Output HS ON delay PWM or DIR 50%  $\rightarrow$  OUT 20% t<sub>don10\_dcm0</sub> SR = 10 6 μs \_ DCmatching = 0 Output HS ON delay PWM or DIR 50%  $\rightarrow$  OUT 20% t<sub>don11\_dcm0</sub> SR = 11 6 μs \_ \_ DCmatching = 0Output HS ON delay PWM or DIR 50%  $\rightarrow$  OUT 20% t<sub>don00 dcm1</sub> SR = 00 8 μs \_ \_ DCmatching = 1 Output HS ON delay PWM or DIR 50%  $\rightarrow$  OUT 20% SR = 01 6 μs t<sub>don01 dcm1</sub> \_ \_ DCmatching = 1 Output HS ON delay PWM or DIR 50%  $\rightarrow$  OUT 20% SR = 10 6 μs t<sub>don10\_dcm1</sub> DCmatching = 1 Output HS ON delay PWM or DIR 50%  $\rightarrow$  OUT 20% SR = 11 6 t<sub>don11\_dcm1</sub> μs \_ DCmatching = 1 Output HS OFF delay PWM or DIR 50%  $\rightarrow$  OUT 80% SR = 00 25 μs t<sub>doff00\_dcm0</sub> -DCmatching = 0 Output HS OFF delay PWM or DIR 50%  $\rightarrow$  OUT 80% SR = 01 20  $t_{doff01\_dcm0}$ μs DCmatching = 0 Output HS OFF delay SR = 10 6 t<sub>doff10\_dcm0</sub> μs PWM or DIR 50%  $\rightarrow$  OUT 80%

### Table 16. Power stage switching parameters



Symbol	Parameter	Condition	Min	Тур	Max	Unit
	DCmatching = 0					
	Output HS OFF delay					
t <sub>doff11_dcm0</sub>	PWM or DIR 50% $\rightarrow$ OUT 80%	SR = 11	-	-	6	μs
	DCmatching = 0					
	Output HS OFF delay					
t <sub>doff00_dcm1</sub>	PWM or DIR 50% $\rightarrow$ OUT 80%	SR = 00	-	-	10.5	μs
	DCmatching = 1					
	Output HS OFF delay					
t <sub>doff01_dcm1</sub>	PWM or DIR 50% $\rightarrow$ OUT 80%	SR = 01	-	-	7	μs
	DCmatching = 1					
tdoff01_dcm1 tdoff10_dcm1 tdoff11_dcm1 ddelta00_dcm0 ddelta01_dcm0 ddelta11_dcm0 ddelta11_dcm1 ddelta00_dcm1 ddelta01_dcm1	Output HS OFF delay					
t <sub>doff10_dcm1</sub>	PWM or DIR 50% $\rightarrow$ OUT 80%	SR = 10	-	-	6	μs
	DCmatching = 1					
	Output HS OFF delay					
t <sub>doff11_dcm1</sub>	PWM or DIR 50% $\rightarrow$ OUT 80%	SR = 11	-	-	6	μs
	DCmatching = 1					
tddelta00_dcm0	Delta HS ON/OFF delay	SR = 00	-5	_	18	μs
-ddenado_denio	DCmatching = 0					
ddelta01_dcm0	Delta HS ON/OFF delay	SR = 01	-1.5	_	10	μs
	DCmatching = 0					
todelta10. dom0	Delta HS ON/OFF delay	SR = 10	-1.5	_	1.5	μs
	DCmatching = 0					
ddelta10_dcm0	Delta HS ON/OFF delay	SR = 11	-1.5	_	1.5	μs
	DCmatching = 0	-				
t <sub>ddelta00</sub> dcm1	Delta HS ON/OFF delay	SR = 00	-4	_	4	μs
	DCmatching = 1					
t <sub>ddelta01</sub> dcm1	Delta HS ON/OFF delay	SR = 01	-2	_	2	μs
	DCmatching = 1					
tdoff00_dcm1       i         tdoff01_dcm1       i         tdoff10_dcm1       i         tdoff11_dcm1       i         tdoff11_dcm1       i         tddoff11_dcm1       i         tddoff11_dcm1       i         tddelta00_dcm0       i         tddelta10_dcm0       i         tddelta11_dcm1       i         tddelta01_dcm1       i         tddelta11_dcm1       i         tddelta11_dcm1       i         tddelta11_dcm1       i         tdon00_spi       i         tdon01_spi       i         tdon10_spi       i	Delta HS ON/OFF delay	SR = 10	-1.5	-	1.5	μs
	DCmatching = 1					
t <sub>ddelta11</sub> dcm1	Delta HS ON/OFF delay	SR = 11	-1	-	1	μs
	DCmatching = 1					Ľ.
	Output HS ON delay					
t <sub>don00 spi</sub>	(SPI control)	SR = 00	_	_	15	μs
	SS 50% → OUTx 20%					·
	DCmatching = 0					
	Output HS ON delay					
t <sub>don01_spi</sub>	(SPI control)	SR = 01	-	-	10	μs
_ ·	SS 50% $\rightarrow$ OUTx 20%					
	DCmatching = 0					
	Output HS ON delay					
t <sub>don10_spi</sub>	(SPI control)	SR = 10	-	-	6	μs
	SS 50% $\rightarrow$ OUTx 20%					
	DCmatching = 0					

Symbol	Parameter	Condition	Min	Тур	Мах	Un
	Output HS ON delay					
	(SPI control)					
t <sub>don11_spi</sub>	SS 50% $\rightarrow$ OUTx 20%	SR = 11	-	-	6	μ
	DCmatching = 0					
	Output HS ON delay					
	(SPI control)				6 8 6 6 25 20	
tdon00_spi_dcm1	SS 50% $\rightarrow$ OUTx 20%	SR = 00	-	-	8	μ
	DCmatching = 1					
	Output HS ON delay				8 6 6 6 25	
	(SPI control)					
tdon01_spi_dcm1	SS 50% → OUTx 20%	SR = 01	-	-	6	μ
	DCmatching = 1					
	Output HS ON delay					
	(SPI control)				8 6 6 25 20 6	
t <sub>don10_spi_dcm1</sub>	SS 50% → OUTx 20%	SR = 10	-	-	6	μ
	DCmatching = 1					
	Output HS ON delay		6			
	(SPI control)					
t <sub>don11_spi_dcm1</sub>	SS 50% → OUTx 20%	SR = 11	-	-	6	μ
	DCmatching = 1					
	Output HS OFF delay					
	(SPI control)				05	
tdoff00_spi_dcm0	SS 50% $\rightarrow$ OUTx 80%	SR = 00	-	-	25	μ
	DCmatching = 0					
	Output HS OFF delay					
	(SPI control)	0.5			00	
tdoff01_spi_dcm0	SS 50% $\rightarrow$ OUTx 80%	SR = 01	-	-	20	μ
	DCmatching = 0					
	Output HS OFF delay				6 25 20 6	
t	(SPI control)	SD = 10			6	
tdoff10_spi_dcm0	SS 50% $\rightarrow$ OUTx 80%	SR = 10	-	-	0	μ
	DCmatching = 0				6 25 20 6	
	Output HS OFF delay					
t	(SPI control)	SD = 11			6	
tdoff11_spi_dcm0	SS 50% $\rightarrow$ OUTx 80%	SR = 11	-	-	0	μ
	DCmatching = 0					
	Output HS OFF delay					
+	(SPI control)				10 5	
t <sub>doff00_spi_dcm1</sub>	SS 50% → OUTx 80%	SR = 00	-	10.5	10.5	h
	DCmatching = 1					
	Output HS OFF delay					
t	(SPI control)	SP = 01			-	
tdoff01_spi_dcm1	SS 50% → OUTx 80%	SR = 01	-	-	7	μ
	DCmatching = 1					



Symbol	Parameter	Condition	Min	Тур	Мах	Un
	Output HS OFF delay					
doff10_spi_dcm1	(SPI control)	SR = 10	-	-	6	με
_ · _	SS 50% → OUTx 80%					
	DCmatching = 1					
	Output HS OFF delay					
doff11_spi_dcm1	(SPI control)	SR = 11	-	-	6	μ
_ · _	SS 50% → OUTx 80%					
	DCmatching = 1					
t <sub>r_HS00_dcm0</sub>		SR = 00	0.975	-	2.4	V/
	-					
	Rise Time HS					
tr HS01 dom0	OUTx 20% → OUTx 80%	SR = 01	3.0	_	5.5	V/µ
	DCmatching = 0					
	Rise Time HS					
tr US10 domo	$OUTx 20\% \rightarrow OUTx 80\%$	SR = 10	12.0	_	30.0	V
	$V_{\rm S}$ = 14 V; Rload = 14 $\Omega$		12.0		00.0	•/
	DCmatching = 0					
	Rise Time HS					
	$OUTx 20\% \rightarrow OUTx 80\%$	SR = 11	15.0	_	35.0	V/I
Y_HS11_dcmU	$V_{S}$ = 14 V; Rload = 14 $\Omega$	517 - 11	15.0		55.0	V/
	DCmatching = 0					
	Rise Time HS					
t uses i i	$OUTx 20\% \rightarrow OUTx 80\%$	SB - 00	0.075		24	V/µ
r_HS00_dcm1	$V_{S}$ = 14 V; Rload = 14 $\Omega$	3R = 00	0.975	-	2.4	V/
	DCmatching = 1					
	$V_{S} = 14 \text{ V; Rload} = 14 \Omega$ $DCmatching = 0$ Rise Time HS $UTx 20\% \rightarrow OUTx 80\%$ $V_{S} = 14 \text{ V; Rload} = 14 \Omega$ $DCmatching = 0$ Rise Time HS $UTx 20\% \rightarrow OUTx 80\%$ $V_{S} = 14 \text{ V; Rload} = 14 \Omega$ $DCmatching = 0$ Rise Time HS $UTx 20\% \rightarrow OUTx 80\%$ $V_{S} = 14 \text{ V; Rload} = 14 \Omega$ $DCmatching = 0$ Rise Time HS $UTx 20\% \rightarrow OUTx 80\%$ $V_{S} = 14 \text{ V; Rload} = 14 \Omega$ $DCmatching = 0$ Rise Time HS $UTx 20\% \rightarrow OUTx 80\%$ $V_{S} = 14 \text{ V; Rload} = 14 \Omega$ $DCmatching = 0$ Rise Time HS $UTx 20\% \rightarrow OUTx 80\%$ $V_{S} = 14 \text{ V; Rload} = 14 \Omega$ $DCmatching = 0$ Rise Time HS $UTx 20\% \rightarrow OUTx 80\%$ $V_{S} = 14 \text{ V; Rload} = 14 \Omega$ $DCmatching = 1$ $Rise Time HS$ $UTx 20\% \rightarrow OUTx 80\%$ $V_{S} = 14 \text{ V; Rload} = 14 \Omega$ $DCmatching = 0$ $Rise Time HS$ $UTx 20\% \rightarrow OUTx 80\%$ $V_{S} = 14 \text{ V; Rload} = 14 \Omega$ $DCmatching = 0$ $Rise Time HS$ $UTx 20\% \rightarrow OUTx 80\%$ $V_{S} = 14 \text{ V; Rload} = 14 \Omega$ $DCmatching = 0$ $Rise Time HS$ $UTx 20\% \rightarrow OUTx 80\%$ $V_{S} = 14 \text{ V; Rload} = 14 \Omega$ $DCmatching = 0$ $Rise Time HS$ $UTx 20\% \rightarrow OUTx 80\%$ $V_{S} = 14 \text{ V; Rload} = 14 \Omega$ $DCmatching = 0$ $Rise Time HS$ $UTx 20\% \rightarrow OUTx 80\%$ $V_{S} = 14 \text{ V; Rload} = 14 \Omega$ $DCmatching = 0$ $Rise Time HS$ $UTx 20\% \rightarrow OUTx 80\%$ $SR = 10$ $I$					
t una c	OUTx 20% $\rightarrow$ OUTx 80%	SD - 01	2		5 5	1.
۲_HS01_dcm1	$V_{\rm S}$ = 14 V; Rload = 14 $\Omega$		3	-	5.5	V/I
tr_HS01_dcm0 tr_HS10_dcm0 tr_HS11_dcm0 tr_HS00_dcm1 tr_HS01_dcm1 tr_HS10_dcm1	DCmatching = 0					
	Rise Time HS					
tures	$OUTx 20\% \rightarrow OUTx 80\%$	CD = 10	10			
чr_HS10_dcm1	$V_{S}$ = 14 V; Rload = 14 $\Omega$	SK = 10	12	-	30	V/
	DCmatching = 0					
	Rise Time HS					
	OUTx 20% $\rightarrow$ OUTx 80%	0.0			05.0	
t <sub>r_HS11_dcm1</sub>	$V_{\rm S}$ = 14 V; Rload = 14 $\Omega$	SR = 11	15.0	-	35.0	V/
	DCmatching = 0					
	Fall Time HS					
t <sub>f_HS00_dcm0</sub>	$OUTx 80\% \rightarrow OUTx 20\%$	SR = 00	-2.4	_	-0.975	V/I
	$V_{\rm S}$ = 14 V; Rload = 14 $\Omega$					'





Symbol	Parameter	Condition	Min	Тур	Max	Uni
	DCmatching = 0					
	Fall Time HS					
t <sub>f_HS01_dcm0</sub>	OUTx 80% $\rightarrow$ OUTx 20%	SR = 01	-5.5	_	-3.0	V/µ
	$V_{S}$ = 14 V; Rload = 14 $\Omega$	517 - 01	-5.5		-5.0	νμ
	DCmatching = 0					
	Fall Time HS					
tr up to down	OUTx 80% $\rightarrow$ OUTx 20%	SR = 10	-30.0		-12.0	V/L
tf_HS10_dcm0	$V_{S}$ = 14 V; Rload = 14 $\Omega$	517 - 10	-30.0		-12.0	V/F
	DCmatching = 0					
	Fall Time HS					
truck	OUTx 80% $\rightarrow$ OUTx 20%	SR = 11	-35.0		-15.0	
<sup>t</sup> f_HS11_dcm0	$V_{S}$ = 14 V; Rload = 14 $\Omega$	SR - 11	-35.0	-	-15.0	V/µ
	DCmatching = 0					
	Fall Time HS					
tr upper tr	OUTx 80% $\rightarrow$ OUTx 20%	SR = 00	-2.4		-0.975	1//-
t <sub>f_HS00_dcm1</sub>	$V_{S}$ = 14 V; Rload = 14 $\Omega$	SR = 00	-2.4	-	-0.975	v/ļ
	DCmatching = 1					
	Fall Time HS					
+	OUTx 80% $\rightarrow$ OUTx 20%	$c_{\rm D} = 0.1$			_	\
t <sub>f_HS01_dcm1</sub>	$V_{S}$ = 14 V; Rload = 14 $\Omega$	SR = 01	-5.5	-	-3	V/ļ
	DCmatching = 1					
	Fall Time HS					
to up to stand	OUTx 80% $\rightarrow$ OUTx 20%	SR = 10	-30		-12	
tf_HS10_dcm1	$V_{S}$ = 14 V; Rload = 14 $\Omega$	SK - 10	-30	-	-12	V/µ
	DCmatching = 1					
	Fall Time HS					
truck	OUTx 80% $\rightarrow$ OUTx 20%	SR = 11	-35.0	_	-15.0	V/µ
t <sub>f_HS11_dcm1</sub>	$V_{S}$ = 14 V; Rload = 14 $\Omega$	517 - 11	-55.0		-15.0	× / F
	DCmatching = 1					
	Rise Time LS					
	OUTx 20% $\rightarrow$ OUTx 80%					
t <sub>r_LS00_dcm0</sub>	$V_{S}$ = 14 V; Rload = 14 $\Omega$	SR = 00	0.975	-	2.4	V/µ
	only valid for DIR change					
	DCmatching = 0					
	Rise Time LS					
	OUTx 20% $\rightarrow$ OUTx 80%					
t <sub>r_LS01_dcm0</sub>	$V_{S}$ = 14 V; Rload = 14 $\Omega$	SR = 01	3.0	-	5.5	V/ļ
	only valid for DIR change					
	DCmatching = 0					
	Rise Time LS					
tr 1 810 dame	OUTx 20% $\rightarrow$ OUTx 80%	SR = 10	12.0	_	30.0	V/L
tr_LS10_dcm0	$V_{S}$ = 14 V; Rload = 14 $\Omega$		12.0		00.0	×/
	only valid for DIR change					

L9969x



Symbol	Parameter	Condition	Min	Тур	Max	Un
	DCmatching = 0					
t <sub>r_LS11_dcm0</sub>	Rise Time LS OUTx 20% $\rightarrow$ OUTx 80% V <sub>S</sub> = 14 V; Rload = 14 $\Omega$ only valid for DIR change DCmatching = 0	SR = 11	15.0	_	35.0	V/I
tr_LS00_dcm1	Rise Time LS $OUTx 80\% \rightarrow OUTx 20\%$ $V_S = 14 V$ ; Rload = 14 $\Omega$ only valid for DIR change DCmatching = 1	SR = 00	0.975	-	2.4	V/I
t <sub>r_LS01_dcm1</sub>	Rise Time LS OUTx 80% $\rightarrow$ OUTx 20% V <sub>S</sub> = 14 V; Rload = 14 $\Omega$ only valid for DIR change DCmatching = 1	SR = 01	3	-	5.5	V/I
tr_LS10_dcm1	Rise Time LS OUTx 80% $\rightarrow$ OUTx 20% V <sub>S</sub> = 14 V; Rload = 14 $\Omega$ only valid for DIR change DCmatching = 1	SR = 10	12	_	3	V/
tr_LS11_dcm1	Rise Time LS OUTx 80% $\rightarrow$ OUTx 20% V <sub>S</sub> = 14 V; Rload = 14 $\Omega$ only valid for DIR change DCmatching = 1	SR = 11	15	_	35	V/
t <sub>f_LS00_dcm0</sub>	Fall Time LS OUTx 80% $\rightarrow$ OUTx 20% V <sub>S</sub> = 14 V; Rload = 14 $\Omega$ DCmatching = 0	SR = 00	-35.0	-	-15.0	V/
f_LS01_dcm0	Fall Time LS $OUTx \ 80\% \rightarrow OUTx \ 20\%$ $V_S = 14 \ V; \ Rload = 14 \ \Omega$ $DCmatching = 0$	SR = 01	-35.0	-	-15.0	V/
t_LS10_dcm0	Fall Time LS OUTx 80% $\rightarrow$ OUTx 20% V <sub>S</sub> = 14 V; Rload = 14 $\Omega$ DCmatching = 0	SR = 10	-35.0	-	-15.0	V/
t <sub>f_LS11_dcm0</sub>	Fall Time LS OUTx 80% $\rightarrow$ OUTx 20% V <sub>S</sub> = 14 V; Rload = 14 $\Omega$ DCmatching = 0	SR = 11	-35.0	-	-15.0	V/
t <sub>f_LS00_dcm1</sub>	Fall Time LS	SR = 00	-35.0		-15.0	V/

L9969x

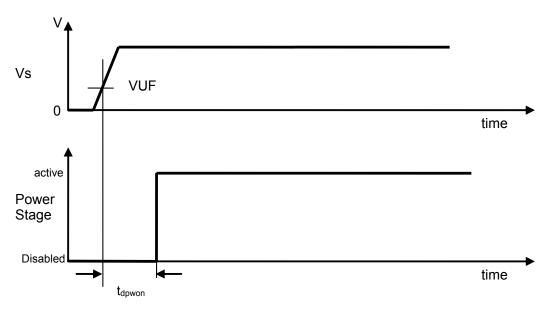
Functional behavior in detail

Symbol	Parameter	Condition	Min	Тур	Мах	Unit
	$OUTx 80\% \rightarrow OUTx 20\%$					
	$V_{\rm S}$ = 14 V; Rload = 14 $\Omega$					
	DCmatching = 1					
	Fall Time LS					
t <sub>f_LS01_dcm1</sub>	$OUTx 80\% \rightarrow OUTx 20\%$	SR = 01	-35.0	_	-15.0	V/µs
4_LS01_ddill1	$V_{\rm S}$ = 14 V; Rload = 14 $\Omega$		00.0		10.0	v/µc
	DCmatching = 1					
	Fall Time LS					
t <sub>f_LS10_dcm1</sub>	OUTx 80% $\rightarrow$ OUTx 20%	SR = 10	-35.0	_	-15.0	V/µs
4_LS10_ddil11	$V_{\rm S}$ = 14 V; Rload = 14 $\Omega$				-15.0	v/µa
	DCmatching = 1					
	Fall Time LS					
triou	OUTx 80% $\rightarrow$ OUTx 20%	SR = 11	-35.0	_	-15.0	V/µs
t <sub>f_LS11_dcm1</sub>	$V_{S}$ = 14 V; Rload = 14 $\Omega$	3K - 11	-35.0	-	-15.0	v/µa
	DCmatching = 1					
f <sub>PWM</sub>	Output switching frequency	-	-	-	20	kHz
	Disable delay time DIS					
t <sub>ddis</sub>	NABE 50% $\rightarrow$ OUTx 20%	-	-	-	12.5	μs
	Resistive load					
t <sub>dpwon</sub>	Power On delay time from power down	$VS = VUF_ON \to output \text{ stages active}$	-	-	1	ms
	Enable delay time from disable status DIS					
t <sub>den</sub>	NABE 50% $\rightarrow$ OUTx 80%	-	-	-	50	μs
	Resistive load					
	Rise Time LS					
t <sub>r_DIS_NABE</sub>	OUTx 20% $\rightarrow$ OUTx 80%	-	60.0	-	-	V/µ
	$V_{S}$ = 14 V; Rload = 14 $\Omega$					
	Fall Time HS					
t <sub>f_DIS_NABE</sub>	OUTx 80% $\rightarrow$ OUTx 20%	-	-	-	-60.0	V/µs
	$V_{S}$ = 14 V; Rload = 14 $\Omega$					

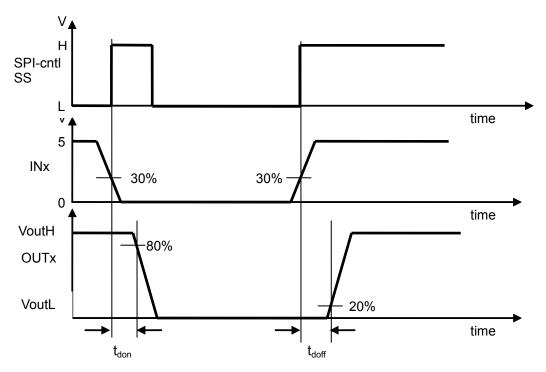
The Output ON delay and the Output OFF delay are designed symmetrically, having, as a result, a deviation of max. 2% of the PWM value between Input Signal (PWM) and Output signal (OUTx) by 20 kHz. In case of output control via SPI interface, the parameters are measured from the positive transition of the SPI NSS signal.



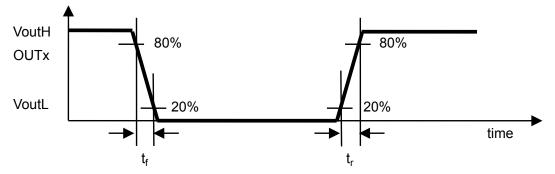














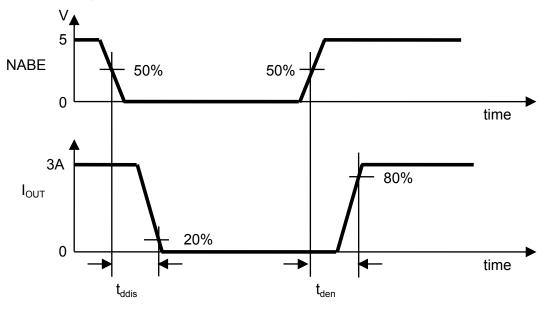
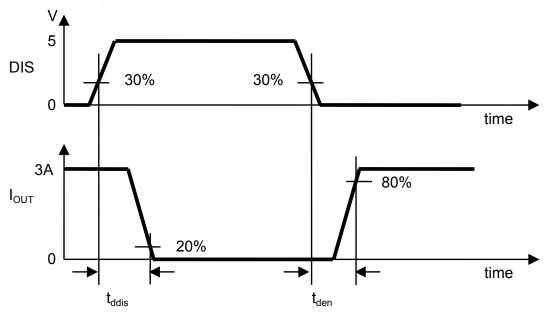


Figure 17. Output disable and enable time - depicted for DIS input





### 3.2.5 Output control

The output stages can be controlled either by two input signals 'PWM' and 'DIR' (parallel control), or via SPI. Parallel control is the default state.

In order to operate the power stages via SPI bus, the CONFIG\_REG.MUX must be set to 0. In this case, the bridges follow the bit values of SDIR and SPWM, in the register CONFIG\_REG. Both releasing signals DIS and NABE keep their effectiveness in this (SPI-controlled) mode of operation. However, when SPI-control mode is selected, signals on PWM and DIR are ignored.

The bit CONFIG\_REG.FW is used to switch between the active free wheeling (CONFIG\_REG.FW = 1), where the body diode is short cut by its transistor, or the passive free wheeling (CONFIG\_REG.FW = 0), where the free wheeling is driven only through the body diode. The active free wheeling (CONFIG\_REG.FW = 1) is the default state; the free wheeling strategy (active versus passive) applies not only to the regular operation of the power stage but also to the current limitation.

### 3.2.6 Protection and monitoring

Both output stages feature the following diagnostic functions:

- Short to Battery voltage (SCB). Detection is performed when low side-switches are turned on. The result is
  reported in the register DIA\_REG1.
- Short to Ground (SCG). Detection is performed when high side-switches are turned on. The result is
  reported in the register DIA\_REG1.
- Short across Load (SCL). Detection is performed by an appropriate procedure (combination SCB, SCG). The result is reported in the register DIA\_REG1.
- Open Load (OL), available in both active and inactive mode. The result is reported in the register DIA\_REG1. Per default only the OL detection in passive is running. If enabled (CONFIG\_REG.OLDA → 1), the OL detection in active mode (OLDA) is run automatically.
- Over Temperature (OT), available in active and inactive mode. Once OT is detected, the power stage is switched off. The result is reported in the register DIA\_REG1.

Each short-circuits error has to be confirmed before it is stored in the DIA\_REG1. In practice, if any error occurs the first time, the HBR has to react correctly. For instance, at SCG at OUT1, the HBR is switched off. After the time t<sub>retest</sub> the HBR is switched on again. If now the SCG at OUT1 appears again, it is confirmed. If it is not confirmed, the first entry is to be skipped. Only confirmed errors are stored in the DIA\_REG1. Open-load in active (OLDA) errors has to be retested as well (refer to Section 3.2.6.9 Open Load diagnosis in active mode). After each confirmed short-circuits error, the HBR is switched off and is not automatically switched on again, even if the error has disappeared in between.

### 3.2.6.1 Current feedback

An analog output signal CF proportional to the load current is provided. The signal CF is valid for 6.5 V <  $V_S$  < 28 V.

5 V < VBATT < 18 V, 4.5 V < VDD < 5.5 V,  $T_J$ = -40 °C to 150 °C, unless otherwise specified.

Symbol	Parameter	Condition	Min	Тур	Max	Unit
CF_0%	CF output voltage with current at OUTx = 0% * $I_L$ (CLx)	I <sub>CF</sub> > -1.2mA	0.008 * VDD	0.014 * VDD	0.036 * VDD	V
CF_5%	CF output voltage with current at OUTx = 5% * $I_L$ (CLx); percentage vs. VDD	I <sub>CF</sub> > -1.2mA	5.27	5.73	6.19	%
CF_40%	CF output voltage with current at OUTx = 40% * $I_L$ (CLx); percentage vs. VDD	I <sub>CF</sub> > -1.2mA	33.7	36	38.3	%
CF_100%	CF output voltage with current at OUTx = 100% * IL (CLx); percentage vs. VDD	I <sub>CF</sub> > -1.2mA	76	88	100	%

### Table 17. Current feedback parameters

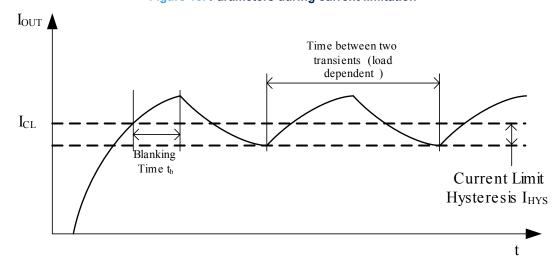
Symbol	Parameter	Condition	Min	Тур	Max	Unit
CF	CF maximum output voltage	-	-100 mV	-	VDD + 200 mV	V

This current feedback signal could be used for certain applications. To get the direction of the current, the signal DIR (HBR control by parallel inputs) or alternatively the information from CONFIG\_REG.DIR is used (HBR control by SPI).

Only positive current (from Outx to GND) at the low side power stage is indicated at the CF output. Negative current and current over the bulk diode are not visible.

### 3.2.6.2 Current limitation

The output stage current limitation levels are adjustable in 3 different ranges, as described in Table 18. The limits are guaranteed over the complete temperature range.



### Figure 18. Parameters during current limitation

Table 18. Current limitation ranges

Symbol	Parameter	Condition	Min	Тур	Max	Unit
I <sub>CL2</sub>	Current limit, selection 2	-	4.25	5.0	5.75	А
I <sub>CL3</sub>	Current limit, selection 3 (default)	-	5.6	6.5	7.6	А
I <sub>CL4</sub>	Current limit, selection 4	-	7.3	8.5	9.9	А
I <sub>CL_HYST</sub>	Current limit, hysteresis	-	-10	-	-5	%
t <sub>b</sub>	Current limit, blanking time	-	8	11	15	μs

Because the current levels are programmed by SPI, the default value is always 'switch off current level' = 3.

A change in one or both input pins terminates the current limitation and the outputs follow the inputs respectively. If the current limitation is running and a load with a high inductive component is connected, the free wheeling may take much time. If the signal on the inputs stays unchanged, the free wheeling will last as long as the lower limit  $(I_L - I_{hys})$  is reached. After that, the path gets active again, the current rises until  $I_L$  is reached, then an additional increase follows for  $t_b$  and then free wheeling is restarted again, in case PWM is still active.

The time between two transients is mainly related to the time constant of the load, and hence not specified. This time however, cannot drop below the limit  $t_{trans_lim}$  defined in Table 19.

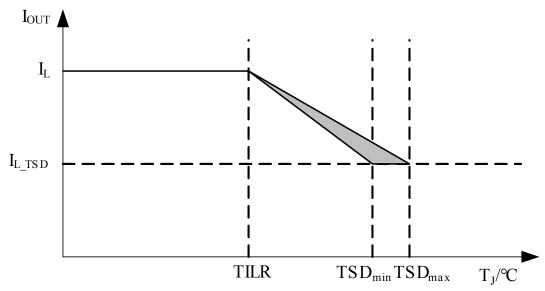
The information that the function "Current limitation" is active is stored in the DIA\_REG2.  $5 \text{ V} < \text{VBATT} < 18 \text{ V}, 4.5 \text{ V} < \text{VDD} < 5.5 \text{ V}, T_J = -40 \text{ °C}$  to 150 °C, unless otherwise specified.

### Table 19. Time between transients

Symbol	Parameter	Condition	Min	Тур	Max	Unit
t <sub>trans_lim</sub>	Time between two transients	-	90	-	130	μs

### 3.2.6.3 Temperature-Dependent Current Reduction (TDCR)

For  $T_{ILR} < T_J < T_{SD}$  the current limit level I<sub>L</sub> decreases from its nominal value (for example typ. 6.6 A for current level 3) down to 2.5 A ± 1.1 A as shown in Figure 19.



### Figure 19. Temperature-Dependent Current Reduction (TDCR)

5 V < VBATT < 18 V, 4.5 V < VDD < 5.5 V,  $T_{\rm J}\text{=}$  -40 °C to 150 °C, unless otherwise specified.

### Table 20. TDCR parameters

Symbol	Parameter	Condition	Min	Тур	Max	Unit
ΙL	Current limit at TSD	-	1.4	2.5	3.6	А
T <sub>ILR</sub>	Start of temperature dependent current reduction	-	150	165	-	°C
T <sub>SD</sub>	thermal shut-down	-	175	190	-	°C
T <sub>SD</sub> - T <sub>ILR</sub>	Range of temperature dependent current reduction	-	20	25	30	°C

### 3.2.6.4 Behavior on faults in general

These are the kind of faults that L9969 is able to detect:

- Faults detected in active or in inactive mode: Open Load (OL), Over Temperature (OT), Undervoltage at Vs (VUF).
- Faults detected in active mode only: Short to GND at OUT1 (SCGOUT1), Short to GND at OUT2 (SCGOUT2), Short to BAT at OUT1 (SCBOUT1), Short to BAT at OUT2 (SCBOUT2), Short across Load (SCL).
- Errors detected in inactive mode: Short to GND at (any) disabled OUTx, Short to BAT at (any) disabled OUTx.

Consequently, errors detected in active mode can only be detected, if the H-bridge is enabled.



 The feature VDD monitoring and the corresponding NABE behavior is not considered here as a power stage error. This is described in Section 2.6.2 NABE and VDD monitoring and in the explanation of VDDMON\_REG.

• There is a difference between errors and information. Information is: CURRLIM (current limitation, reported in DIA\_REG2) and TDCR (temperature dependent current reduction, reported in DIA\_REG2).

During the retest procedure for confirming an error, the H-bridge will not react on any signal (and on any signal transition) on PWM or DIR.

Also, after every confirmed error the H-bridge is switched off and is not automatically switched-on again, even if the error has disappeared in between.

### 3.2.6.5 Short circuit detection

Both high side power stages are supervised continuously to detect any short circuit to ground or short circuit across load on OUT1 or OUT2. If the current rises during the blanking time  $t_b$  beyond the limit  $I_{ouk}$ , a short circuit to ground is detected. The H-bridge is switched off. After that, the error has to be confirmed in a first step, and it has to be checked whether there is only a simple short cut present or a SCL in a second step. This is to distinguish by an appropriate internal test procedure, refer to Section 3.2.6.6 Short circuit across load.

Both low side power stages are supervised to detect any short circuit to battery or short circuit across load on OUT1 or OUT2. If the current rises during the blanking time  $t_b$  beyond the limit louk, a short circuit to battery or short circuit across load is detected. The HBR is switched off. Then the error has to be confirmed, the HBR is switched on again. If the short circuit to battery is detected again, the error will be reported to the DIA\_REG1. This is to distinguish by an appropriate internal test procedure, refer to Section 3.2.6.6 Short circuit across load.

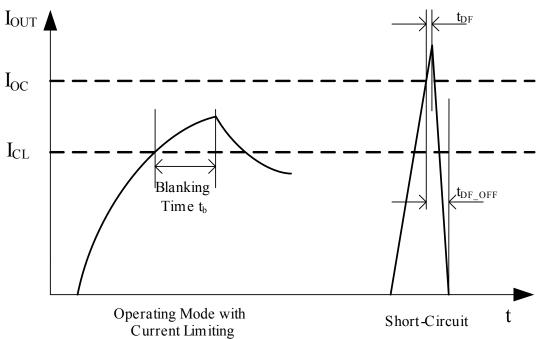


Figure 20. Short circuit detection principle

In fault case at any output pin, all output stages are switched off. Each half-bridge output stage is equipped with a short circuit protection up to battery voltages of 40 V.

Parameters for overcurrent detection are specified in the range of 8 V to 18 V. The specified limits may vary in the range below 8 V (down to 5.5 V of min VSx) or above 18 V, however the function itself is guaranteed up to 40 V at  $V_S$ .

A short circuit condition at level 3 shall be detected, if the circuit, attached to the output, has an impedance  $\leq 0.5$   $\Omega$  and  $\leq 25 \mu$ H at battery voltage of 13 V and 25 °C junction temperature.

In order to get a good robustness against wrongly detected short circuits, especially with high battery voltages, L9969 is designed in order to keep a certain gap between short-circuit limit and current limitation threshold under all circumstances.

 $5 \text{ V} < \text{VBATT} < 18 \text{ V}, 4.5 \text{ V} < \text{VDD} < 5.5 \text{ V}, T_J = -40 ^{\circ}\text{C}$  to 150  $^{\circ}\text{C}$ , unless otherwise specified.



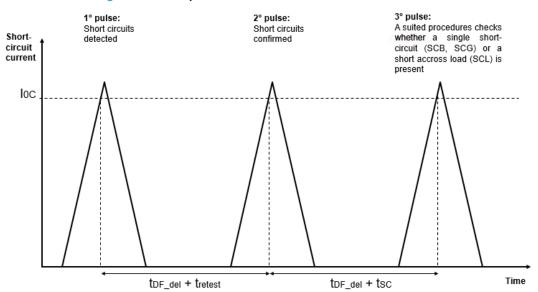
Symbol	Parameter	Condition	Min	Тур	Max	Unit
I_ouk_2	Overcurrent detection at CL = 2	Short Circuit to Ground or Battery or Across Load	4.9	-	8.2	A
I_ouk_3	Overcurrent detection at CL = 3 (default)	Short Circuit to Ground or Battery or Across Load	6.7	-	11.1	Α
I_ouk_4	Overcurrent detection at CL = 4	Short Circuit to Ground or Battery or Across Load	8.4	-	14	A
Δ Ι <sub>ΟUK</sub>	Short circuit current tracking  IOUK  -  Current Limit IL	-	0.3	-	-	Α
t <sub>DF_H</sub>	Delay time for fault detection	0.5 Ω at 25 μH	1	2	-	μs
t <sub>DF_off</sub>	Time from detected fault to high impedance of outputs	0.5 Ω at 25 μH	-	-	6	μs
t <sub>DF_del</sub>	Free-wheeling time. Time for the delayed switch off between the switch off of both outputs after a detected short circuit at one output	-	20	-	200	μs
t <sub>SC</sub>	Timeout during reconfirmation sequence	-	290	350	413	μs
t <sub>retest</sub>	Duration of the switch on/switch off sequence of OUTx after a detected short circuit at one output	-	290	350	413	μs

### Table 21. Short circuit detection parameters

Each error has to be confirmed before being stored in the DIA\_REG1.

#### 3.2.6.6 Short circuit across load

In case of a short circuit across load, it is possible that two failures are detected at the same time (but not necessarily): a short to ground on one side and a short to battery on the other side. The HBR has to run a sequence internally, if there is only a single short circuit to ground on the high-side switch or a single short circuit to  $V_S$  on the low side switch or if there is really a short circuit across the load. This sequence is executed every time a single short cut is detected, to prevent a false error reporting. The SCL algorithm should look as follows (see Figure 21).



#### Figure 21. Principle of the short circuit across load detection

When an error was detected at any output pin the output stages are turned off immediately. Below, some examples of how the SCL detection procedure works.



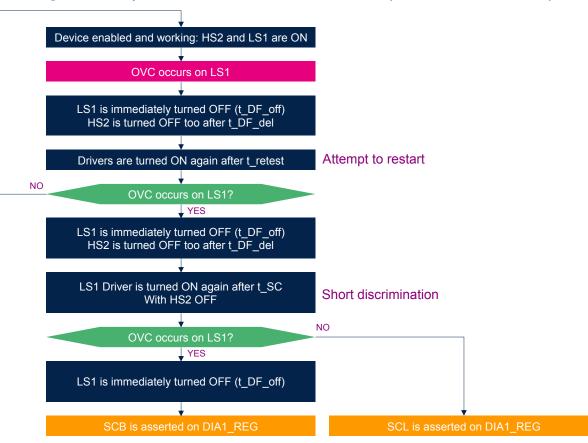


Figure 22. Principle of the short circuit across load detection (OVC on LS1 when PWM = 1)



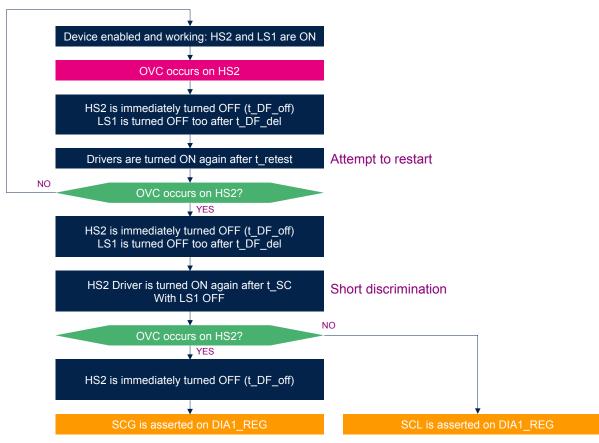


Figure 23. Principle of the short circuit across load detection (OVC on HS2 when PWM = 1)

### 3.2.6.7 Short Circuit detection and behavior afterwards

- After a detected short circuit (SCG, SCB or SCL) both outputs are switched to tri-state.
- If only one output has diagnosed a short circuit, the second output is switched off after a delay time t<sub>DF\_del</sub>. This delay time allows the free-wheeling of the inductive energy stored in the load.
- If a short circuit is detected on both outputs, they are both switched off immediately. If the second short
  circuit is detected during t<sub>DF del</sub>, the second output is switched off immediately too.

Anytime a SCB or a SCG is detected, L9969 allows to distinguish if there is only a single SC or a SCL. Therefore a sequence starts running internally after the detected fault SCB or SCG. This sequence of confirmation is short enough to prevent any mechanical reaction in the connected load.

This is checked internally by switching the second half-bridge to GND and the first half-bridge to GND too, by releasing the power-stage for a short period t<sub>retest</sub>. If now the SCB on OUT1 disappears, one has a SCL, otherwise the SCB on OUT1 is detected correctly. This testing is different from the normal operation, where only one diagonal path is switched.

Theoretically, there could be the following failure scenario: as DIRx=0 and PWMx=0, a short to battery on OUTx1 occurs, consequently a short to battery detection on OUTx1 LS eventually leads to both OUTx1 LS and OUTx2 LS drivers turn-OFF after filter-time; t\_RETEST timer starts. During t\_RETEST counting, the short condition changes from short to battery on OUTx1 to short to ground on OUTx1; as t\_RETEST counting expires, both OUTx1 LS and OUTx2 LS drivers are re-enabled and the previous fault detection is not confirmed and bridge actuation control returns to the PWMx pin. As PWMx pin status changes back from 0 to 1, OUTx1 HS driver is enabled as requested; by the way, short to ground on OUTx1 is present, thus both OUTx1 HS and OUTx2 LS drivers are turned-OFF after filter-time: as no further scenario change occurs, the short confirmation procedure is completed, confirming the short to ground on OUTx1.

#### 3.2.6.8 Undervoltage shutdown

In case of undervoltage on V<sub>S</sub>, L9969 reacts by shutting down. The diagnosis of V<sub>S</sub> undervoltage is also available on SPI registers; in fact undervoltage on V<sub>S</sub> does not reset the SPI interface. The involved parameters in undervoltage shutdown are reported in Table 22.



5 V < VBATT < 18 V, 4.5 V < VDD < 5.5 V,  $T_J$ = -40 °C to 150 °C, unless otherwise specified.

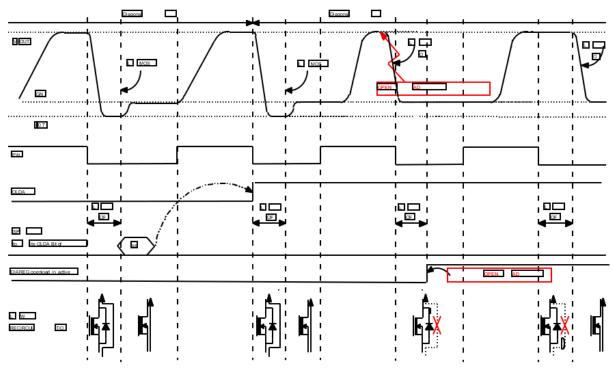
Symbol	Parameter	Condition	Min	Тур	Мах	Unit
VUF_OFF	Undervoltage at $V_S$ , switch off threshold	-	3.1	3.8	4.5	V
VUF_ON	Undervoltage at $V_S$ , switch on threshold	-	3.3	4.0	4.7	V
VUF_HYS	Undervoltage at V <sub>S</sub> , hysteresis	-	100	-	1000	mV
tUF	Filter time detection undervoltage $V_S$	-	-	-	1,5	μs

#### Table 22. Undervoltage shutdown parameters

#### 3.2.6.9 Open Load diagnosis in active mode

Open Load diagnosis is possible when outputs are switched off by DIS or NABE but also during active operation, in case the feature is enabled via CONFIG\_REG.OLDA = 1. However, default value for the open load diagnosis during active operation is: disabled (CONFIG\_REG.OLDA = 0).

Figure 24 shows how this could be achieved.



#### Figure 24. Open Load diagnosis in active mode

In active mode, by default the Open Load diagnostic is deactivated. If one has sent the command CONFIG\_REG.OLDA mode = 1, the Open Load diagnostic in active mode (OLDA) is activated. In Figure 24, at the beginning, the OLDA is deactivated. The load is assumed to have an inductive component. The current in the load is toggled by the signal PWM. If the PWM signal is low, one has the free-wheeling of the inductive component of the load via the low-side transistors. At the beginning of the free-wheeling phase, the inductivity must free-wheel. Therefore it is generating a negative voltage on the OUTx. This voltage is detected internally the HBR. As long as there is a negative voltage at the beginning of the free-wheeling phase, no open load fault has occurred. If there is no negative voltage at the beginning of the free-wheeling phase, there is an open load (or a simple resistor connected as load, where this principle does not work).

This principle only works at load currents above a certain threshold. If the load current is below that limit, the free wheeling phase is too short to be detected correctly. This threshold is not specified here but it must be considered in any case in order not to lead to a wrong diagnosis.

Once an OLDA was detected, the error has to be confirmed before being reported in DIA\_REG1. The way how the confirmation algorithm works, can be set in SPECIAL\_REG, Bit4 (OLDAFILTER). Two alternatives are possible: either the error has to be confirmed during the next possible retry, or the error has to be confirmed during a retry after 40 ms.

5 V < VBATT < 18 V, 4.5 V < VDD < 5.5 V,  $T_J$ = -40 °C to 150 °C, unless otherwise specified.

#### Table 23. Under ground thresholds parameters

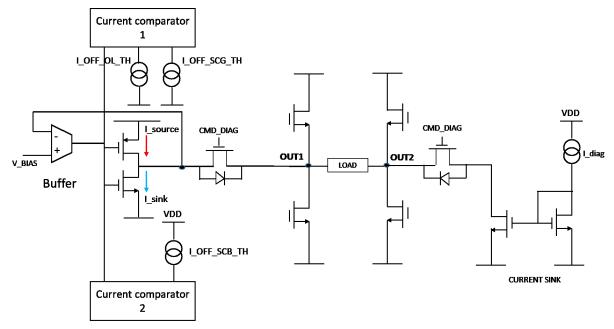
Symbol	Parameter	Condition	Min	Тур	Мах	Unit	Pin
V <sub>UGND_OUTxy</sub>	Under ground threshold voltage at OUTxy	1	-0.25	-0.15	-0.05	V	OUTxy

#### 3.2.6.10 Diagnosis in inactive mode

In inactive mode, i.e the HBR is disabled via the signals NABE or DIS, both the outputs OUT1 and OUT2 are in the tristate condition (all four power transistors are switched off). In order to avoid any wrong diagnostic by generated effects of the connected load, a filtering time  $t_{diag}$  OL must have expired before the diagnosis is run.

In inactive mode, the following diagnostics are available: Open Load, Short to Ground and Short to Battery. At power-up if load is not connected and OUTx1 is shorted to battery voltage or GND, the diagnosis detects SCG or SCB and no OL.

Figure 25 shows how the OFF diagnosis is working, when the power-stage is disabled.



#### Figure 25. Principle of diagnosis in inactive mode

When the OFF state diagnosis is enabled, an internal buffer regulates a typical voltage of 1.8 V ( $V_{OFF_OUT1}$ ) on OUTx1 pin, with a certain  $I_{SOURCE}$  and  $I_{SINK}$  capability, whose limits are equal to  $I_{OFF\_LIM\_SRC\_OUT1}$  and  $I_{OFF\_LIM\_SRC\_OUT1}$  respectively; on OUTx2 is present pull-down current ( $I_{OFF\_PD\_OUT2}$ ), whose typical value is 120 µA.

If the load is connected and its resistance is below  $R_{OL}$ , the buffer shall source a current equal to  $-I_{OFF_PD_OUT2}$ , so the diagnostic result is "no fault".

If  $I_{SOURCE}$  becomes higher than  $I_{OFF\_OL\_TH}$  (lower in absolute value), it means that load is disconnected, or its resistance has become more than  $R_{OL}$ , so the diagnostic result is Open Load.

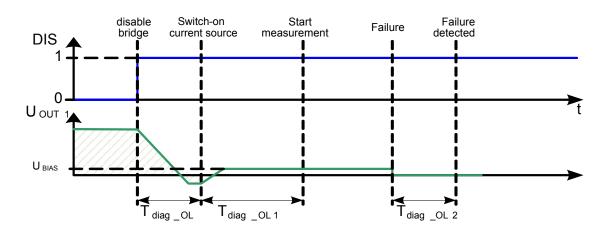
If  $I_{SOURCE}$  becomes lower than  $I_{OFF\_SCG\_TH}$  (higher in absolute value), it means that there is a short to ground. If  $I_{SINK}$  becomes higher than  $I_{OFF\_SCB\_TH}$ , it means that there is a short to battery.

5 V < VBATT < 18 V, 4.5 V < VDD < 5.5 V, T\_J= -40  $^\circ C$  to 150  $^\circ C$ , unless otherwise specified.

Symbol	Parameter	Condition	Min	Тур	Max	Unit	Pin
V <sub>OFF_OUT1</sub>	OUT1 regulated output voltage, used for OFF diagnostics	-2.4 mA < I <sub>OUT1</sub> < 2.9 mA	1.2	1.8	2.4	V	OUTx1
IOFF_PD_OUT2	OUT2 pulldown current, used for OFF diagnostics	V <sub>OUT2</sub> = 1.6 V	90	120	150	μA	OUTx2
I <sub>OFF_OL_TH</sub>	Open-load threshold used for OFF diagnostics, measured at OUT1	-	-80	-60	-30	μA	OUTx1
IOFF_SCB_TH	Short to battery threshold used for OFF diagnostics, measured at OUT1	-	250	380	500	μA	OUTx1
I <sub>OFF_SCG_TH</sub>	Short to ground threshold used for OFF diagnostics, measured at OUT1	-	-2.3	-2	-1.3	mA	OUTx1
IOFF_LIM_SRC_OUT1	OFF diagnostic regulator sourcing current limit, measured at OUT1	V <sub>OUT1</sub> = 0 V	-5.7	-4.1	-2.4	mA	OUTx1
IOFF_LIM_SNK_OUT1	OFF diagnostic regulator sinking current limit, measured at OUT1	2.5 V < V <sub>OUT1</sub> < 18 V	2.9	4.1	5.4	mA	OUTx1
R <sub>OL</sub>	Load detection threshold	-	2.5	-	50	kΩ	-
t <sub>diag_OL</sub>	Delay before enabling Open Load diagnostic structure	-	100	-	150	ms	-
t <sub>diag_OL_1</sub>	Delay before starting measurement	-	2.4	-	3.6	ms	-
t <sub>diag_OL_2</sub>	Open Load diagnostic filtering time	-	200	-	300	μs	-

Table 24. OFF state diagnostic detection parameters

#### Figure 26. Timings related to Open Load diagnostics



This means, the open load diagnosis starts automatically after  $t_{diag_OL} + t_{diag_OL_1}$ . If now there is no open load condition, the diagnosis phase keeps on running. If the open load condition is detected, this condition must be valid for a time  $t_{diag_OL_2}$ . If this is the case, OL is reported to the DIA\_REG1. The OL structure keeps on working, so that if the OL disappears and reappears after a certain time, it is detected again, automatically and without any external trigger.



#### 3.2.7 SPI Interface

#### 3.2.7.1 SPI general description

The SPI interface establishes a communication between the H-bridge and the systems microcontroller. The H-bridge is always operated in the slave mode whereas the microcontroller provides the master functions.

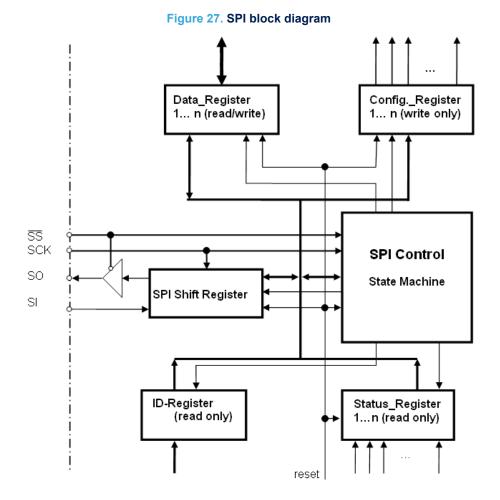
By applying an active slave select signal at NSS, the H-bridge is selected by the SPI master. SI is the data input (Slave In), SO the data output (Slave Out). Via SCK (Serial Clock Input), the SPI clock is provided by the SPI master.

In case of inactive slave select signal (high), the data output SO is in high impedance state (tristate).

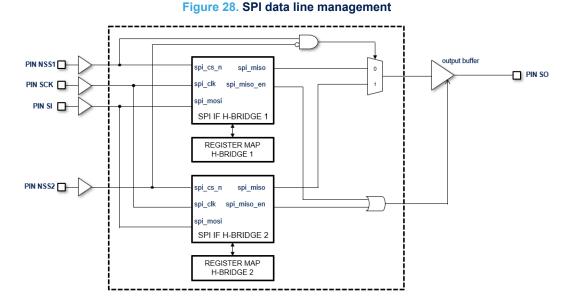
Depending on the application, the first two bits of an instruction may be used to establish an extended deviceaddressing. Doing this, one common NSS channel may be shared by up to 4 Slave-devices.

Thresholds are independent from VDD and defined in a way to be compatible to 3.3 V and 5.0 V ports, if VDD is in its operational range.

In absence of V<sub>S</sub>, the full functionality of the SPI-interface is still given.



For twin version, since there are two NSS pins competing for the data lines, they must not be asserted simultaneously. In the event that this occurs, the data lines will be managed as shown in the figure below:



If both the NSS were to be asserted and the communication did not have problems such as those indicated in the following paragraphs, the action will be taken in both bridges. The NSS1 signal has priority over the NSS2, therefore, the value that will be reported on the data output SO will depend on how the two signals are driven.

#### 3.2.7.2 SPI communication

A SPI communication always starts with an SPI instruction sent from the controller to the H-bridge.

During a write cycle the controller sends the data after the SPI instruction, beginning with the MSB.

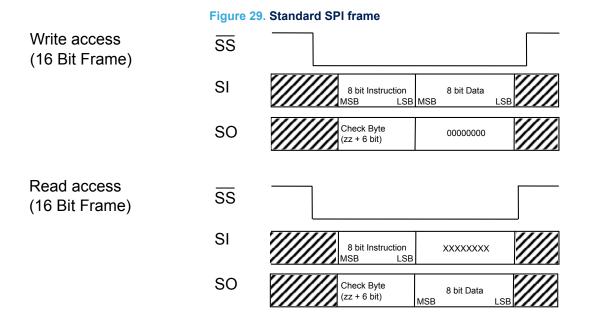
During a reading cycle, after having received the SPI instruction, the H-bridge sends the corresponding data to the controller, also starting with the MSB.

In general, depending on the specific application four different frame types are supported (see the table below). The frames-types are defined by the number of bits being transferred during an active slave-select phase (falling SCK-edges during NSS = low).

#### Table 25. Frame Types

Instruction	Data				
Standard:	16-bit frame	8 bits	8 bits		
Extended_2 is not used in H-bridge	-	-	-		
Extended_3 is not used in H-bridge	-	-	-		
Burst frame types are not used in H-bridge	-	-	-		





Since the coding of the SPI instructions is done in such a way that at least at bit 5 it is clear, whether a reading or a writing instruction is sent, and moreover, the instructions are not using the LSB of the instruction, there is at least a duration of one bit left in order to provide the requested data for the SO.

#### 3.2.7.3 Characteristics of the SPI interface

The characteristics of the SPI interface are the following:

- **During active reset conditions:** the SPI is driven in its default state. When reset becomes inactive, the state machine enters in a wait state for the next instruction. During active reset conditions the output SO is in high impedance state (tristate).
- If the slave-select signal at NSS is inactive (high): the state machine is forced to enter the wait state, that is the state machine waits for the following instruction.
- During active (low) state of the select signal SS: the falling edge of the serial clock signal SCK will
  be used to latch the input data at SI. Output data at SO are driven with the rising edge of SCK. Further
  processing of the data according to the instruction (that corresponds to the modification of the internal
  registers) will be triggered by the rising edge of the NSS signal.
- Chip address: in order to establish the option of extended addressing, the uppermost two bits of the instruction-byte (that is the first two SI-bits of a frame) are reserved to send a chip address. For future orientation, a configurable chip-address is requested. This should be achieved by connecting the chip-address register-bits to an electrical low or high potential onto the silicon. The default chip-address (as specified in Section 3.2.7.4 SPI Instruction) should always be 00hex. However, a switch-over, by modifying the bond-wire configuration onto the silicon should be possible later on for a dedicated derivate. As alternative a mask option or fuse can be also used. To avoid a bus conflict the output SO must stay in high impedance state during the address does not match, the corresponding access will be ignored and SO remains high impedance for the complete frame regardless of the frame type that is applied. Even in case the lower instruction bits match to a valid instruction, there is no impact on internal registers or any functions (including the Transfer Failure Message).
- **Check byte:** during the receiving of an SPI instruction, the H-bridge transmits a check byte via the output SO to the controller. This byte indicates the correctness of the operation of the SPI. It contains an initial bit pattern and a flag indicating possible invalid instruction of the previous access.
- Read and write access: during a read access the data bits at the SPI input SI are rejected/ignored. During a valid write access the SPI will transmit the data byte "00<sub>hex</sub>" at the output SO after having sent the check byte. When a Bit in the Register is cleared during Read-Access this will be done when the communication is finished successfully (rising edge of SS after 16 bits).



Invalid instruction/access: an instruction is invalid, if one of the following conditions is fulfilled: a) an unused instruction code is detected (see Table 26), b) in case the previous transmission is not completed in terms of internal data processing (violation of the minimum access-time). If an invalid instruction is detected, no modifications of the registers of the H-bridge are allowed. In case an unused instruction code has occurred, the data byte "FF<sub>hex</sub>" will be transmitted after having sent the check byte. In order to guarantee the proper operation of the corresponding circuitry the active NSS signal must be stable for at least 50ns. In addition any access is invalid if the number of SPI clock pulses (falling edge) counted during active NSS differs from exactly 16 clock pulses. A write access will be internally rejected (that is internal registers will not be affected) in case the number of falling edges applied to the SPI input SCK during the access is not equal to 16.

#### 3.2.7.4 SPI Instruction

The uppermost 2 bits of the instruction byte are reserved to feature extended chip addressing.

The individual chip address is an option and has to be defined in accordance to the SPI-Members sharing one NSS line.

Only when the first two bits after the falling edge of NSS are matching, the H-bridge is allowed to transfer data on SO.

MSB											
7	6	5	4	3	1	0					
CPAD1	CPAD0	INST5	INST4	INST3	INST2	INST1	INST0				
Bit	Nan	ne			Description						
7	CPAD1 (	INST7)	Chip Address: Mask-Option Value: 0 (via pad configuration)								
6	CPAD0 (	CPAD0 (INST6) Chip Address: Mask-Option Value: 0 (via pad configuration)									
50	INS	Τ5	Read/Write: Read: 0 Write: 1								
40	INST4	40	SPI instruction								

#### Table 26. SPI Instruction byte

#### 3.2.7.5 Check byte

#### Table 27. Check byte

	MSB											
7	6	5	4	3	2	1	0					
Tristate	Tristate	1	0	1	0	1	TRANS_F					
Bit	Name		Description									
7	-	Tri state ( hig	ri state ( high impedance )									
6	-	Tri state ( hig	Tri state ( high impedance )									
5	-	Fixed to High	Fixed to High									
4	-	Fixed to Low										
3	-	Fixed to High										
2	-	Fixed to Low										
1	-	Fixed to High										
0	TRANS_F	Transfer-Failu	Transfer-Failure: (reset value '0')									
TRANS_F TRANS_F = 0: Previous Transfer was recognized as valid;												

#### MSB

TRANS\_F = 1: Error detected during previous transfer (regarding the actual device, that is: chip address valid)

#### 3.2.7.6 SPI registers overview

In Table 28 all the commands to access the SPI registers are summarized.

#### Table 28. SPI registers overview

Command	INST[70]	Description
RD_ID	0000 0100	Read device ID
RD_REV	0000 0110	Read device Revision
RD_DIA1	0001 0000	Read power stage diagnostic information (1)
RD_DIA2	0001 1000	Read power stage diagnostic information (2)
RD_CONFIG	0000 1000	Read power stage configuration
RD_STATCON	0000 1100	Read VDD monitoring status
RD_SPECIAL	0000 1110	Read information from SPECIAL
WR_DIA1	0011 0000	Write special bits in DIA1
WR_DIA2	0011 1000	Write special bits in DIA2
WR_CONFIG	0010 1000	Write power stage configuration
WR_STATCON	0010 1100	Write VDD monitoring status
WR_SPECIAL	0010 1110	Write information to SPECIAL
All other	00xx xxxx	Unused, TRANS_F is set to high,
An other		ff hex is sent as data bits

The SFR list describes all the different reset sources. On every SPI register detail, in the next paragraphs, the values of the reset sources after the different resets are also shown.

#### Table 29. SFR List description

	Reset Sources									
POR	Reset after VDD is rising above VDD_POR threshold after the ASIC was disabled during VDD undervoltage.									
SPIR	Reset activated by set the bit CONFIG_REG.RESET='0' via SPI									
ENDISR	Reset by disable-enable sequence via ABE or DIS Signal (edge triggered)									
DISR	Reset by disabling the power stage (DIS or ABE level triggered)									
DIACLR1	Reset by setting the bit STATCON_REG.DIACLR1='0'									
DIACLR2	Reset by setting the bit STATCON_REG.DIACLR2='0'									
RDR	Reset after SPI Read out of the Register									
	Reset behavior of the Register content									
1	Bit will be changed to '1'									
0	Bit will be changed to '0'									
x	No change of the bit content									

#### 3.2.7.6.1 Device identifier

The H-bridge's identifier is used for production test purposes and features plug and play functionality depending on the systems software release. It is made up of a device-number and a revision number each one read-only accessible via standardized instructions.



The device number is defined once to allow identification of different IC-Types by software.

The revision number may be utilized to distinguish different states of hardware. The content is divided in an upper 4-bit field reserved to define revisions corresponding to specific Software Releases.

The lowest 4-bit field is utilized to identify the actual mask set.

Both (SWR and MSR) will start with 0000b and are increased by 1 every time a corresponding modification of the hardware is introduced.

Bit	7	6	5	;	4	3		2	1	0		
Bit-Name	ID7	ID6	ID	5	ID4	ID3		ID2	ID1	ID0		
POR	1	1	C		1	1		1	1	1		
SPIR	1	1	0		1	1		1	1	1		
ENDISR	x	х	x		x	x		х	x	x		
DISR	x	x	×		x	x		х	x	x		
RDR	x	x	×		x	x		х	x	x		
Controller access: read	Controller access: read only						(read-access: RD_ID)					
Bit Name					Description							
70	ID7ID0				Device number: 0xDF							

#### Table 30. Register ID\_REG

#### Table 31. Register REV\_REG

Bit	7	6	5	4	3	2	1	0		
Bit-Name	SWR3	SWR2	SWR1	SWR0	MSR3	MSR2	MSR1	MSR0		
POR	0	1	0	0	0	0	0	0		
SPIR	0	1	0	0	0	0	0	0		
ENDISR	x	x	х	х	х	х	x	x		
DISR	x	x	х	х	х	х	x	х		
RDR	x	x	х	x	x	х	x	x		
Controller a	ccess: rea	d only		(read-access:	RD_REV)					
Bit		Name		Description						
74	SWF	3SWR0	Revision	Revision corresponding to software release default: 4 <sub>hex</sub>						
30	MSF	83MSR0	Revision	Revision corresponding to mask set default: $0_{hex}$ ; in AA silicon: $0_{hex}$						



#### 3.2.7.6.2 Status register (read and write access)

	Table 32. Register DIA_REG1										
Bit	7	6	5	4	3	2	1	0			
Bit-Name	NABE_DIS	ОТ	Var1	Var0	DIA21	DIA20	DIA11	DIA10			
POR	x	1	1	1	1	1	1	1			
SPIR	x	1	х	x	1	1	1	1			
ENDISR	x	1	х	x	1	1	1	1			
RDR	x	x	х	x	×	x	x	x			
DIACLR1	x	1	х	x	1	1	1	1			
Controller access: read/write (write-access: WR_DIA1)											
				(read-access: F	RD_DIA1)						
Bit	Name			Description							
7	NABE_C	IS		0: NABE = Low or/and DIS = High (not latched) (r) 1: NABE = High and DIS = Low							
6	ОТ		0: Over Ten 1: no Over	nperature Temperature		(latched)	(latched) (r)				
5	VAR1		r/w for spec	ial use		(latched)	(r/w)				
4	VAR0		r/w for spec	ial use		(latched)	(r/w)				
3	DIA21										
2	2 DIA20 1 DIA11			2 holow		(r)					
1				See Table 33 below			(r)				
0	DIA10										

#### Table 33. Diagnosis bits (DIA\_REG1)

DIA21	DIA20	DIA11	DIA10	Description	Remark			
0	0	0	0	Not used				
0	0	0	1	Short Circuit to Ground at OUT1 (SCG1)	latched			
0	0	1	0	Short Circuit to Ground on OUT2 (SCG2)	latched			
0	0	1	1	Netwood				
0	1	0	0	Not used				
0	1	0	1	Short Circuit to Battery on OUT1 (SCB1)	latched			
0	1	1	0	Short Circuit to Battery on OUT2 (SCB2)	latched			
0	1	1	1	Short Circuit across load (SCL)	latched			
1	0	0	0	Short Circuit to Battery at disabled output	latched			
1	0	0	1	Short Circuit to Ground at disabled output	latched			
1	0	1	0	Open Load (at disabled output or in active)	latched			
1	0	1	1	Not used				
1	1	0	0	Not used				
1	1	0	1	Undervoltage at pin V <sub>S</sub>	Not latched			
1	1	1	0	Not used				
1	1	1	1	No failure	-			

In DIA\_REG1 the errors are stored. A read process does not reset DIA\_REG1.

Reported errors are: Open Load (OL), Over Temperature (OT), Short Circuit (SCG1, SCG2, SCB1, SCB2, SCL). General description, how the DIA\_REG1 and the DIA\_REG2 are related together:

- Any time, an error is detected, the HBR is switched off (exception: Open Load diagnosis)
- The detected error is to be confirmed or in the case of short circuit to clarify, if single SC or SCL
- The confirmed error is set in DIA\_REG1
- The HBR can only get active again after Power on reset, this is the reset source POR or after disabling enabling sequence, this is the reset source ENDISR
- The HBR is disabled by the operating software in the control unit, this is the usual procedure
- Some other action from the operating software in the control unit may happen, f.i. resetting DIA\_REG1
- So in the DIA\_REG1 there is still the error code or the DIA\_REG is reset
- Finally the HBR will be enabled again (ENDISR) by the operating software

If a fault is detected, the H-bridge is switched off and the error is entered in the DIAREG1 (short circuit error after confirmation).

After EN/DIS sequence or setting DIACLR1 the diagnostic related to the error in DIAREG1 is transferred to DIAREG2 and DIAREG1 is cleared.

If now another error happens, the H-bridge is switched off and the new error is entered in the DIAREG1.

#### **Remarks:**

The errors can be reset selectively. By writing STATCON\_REG.DIACLR2 = 0, this resets all errors in DIA\_REG2, that is the previous errors. By writing STATCON\_REG.DIACLR1 = 0, this transfers all latched errors from DIA\_REG1 to DIA\_REG2 and resets DIA\_REG1 afterwards, if there is no under voltage condition existing.

To completely delete the whole error log, the following sequence has to be transmitted via SPI:

- STATCON\_REG.DIACLR1 = 0
- STATCON\_REG.DIACLR2 = 0

Undervoltage at V<sub>S</sub> (there is no error but condition):

If there is any error stored and additional the condition 'undervoltage' occurs, the condition 'undervoltage' is reported as long as the undervoltage condition is present. If the undervoltage condition disappears, the previously reported error is present again until it is reset.

**NABE\_DIS** always shows directly the status of the power stages. NABE\_DIS is set to '0', if the power stages are disabled by NABE or DIS or (NABE and DIS).

Bit	7	6	5	4	3	2	1	0		
Bit-Name	CurrRed	CurrLim	ОТ	Var2	DIA21	DIA20	DIA11	DIA10		
POR	1	1	1	0	1	1	1	1		
SPIR	1	1	1	x	1	1	1	1		
ENDISR	1	1	х	x	x	х	х	x		
RDR	1	1	х	x	x	х	х	x		
DIACLR2	1	1	1	x	1	1	1	1		
C	Controller access: read/write (write-access: WR_DIA2))									
					(read-access: RD	_DIA2				
Bit	N	ame			Description					
			Temperature of	depend current redu	ction (TDCR) [no erroi	r]				
7	Cu	rrRed	0: TDCR is ac	tive		(latched) (r)				
			1: TDCR is no	ot active						
	~	and the	Current Limita	ation (CL) [no error]						
6	Cu	ırrLim	0: CL is active (latched) (r)							

#### Table 34. Register DIA\_REG2

Bit	7	6	5	4	3	2	1	0		
6	Cu	ırrLim	1: CL is not a	I: CL is not active						
5		ОТ	It is the previo	is the previously OT error from DIA_REG1 (latched) (r)						
4	V	AR3	r/w for specia	r/w for special use (latched) (r/w)						
3	D	IA21								
2	D	IA20	Coo Toble 25	balaw						
1	D	IA11		See Table 35 below (r)						
0	D	IA10								

#### Table 35. Diagnosis bits (DIA\_REG2)

DIA21	DIA20	DIA11	DIA10	Description	Remark		
0	0	0	0	Not used			
0	0	0	1	Short Circuit to Ground at OUT1 (SCG1)	latched		
0	0	1	0	Short Circuit to Ground on OUT2 (SCG2)	latched		
0	0	1	1	Netwood	'		
0	1	0	0	Not used			
0	1	0	1	Short Circuit to Battery on OUT1 (SCB1)	latched		
0	1	1	0	Short Circuit to battery on OUT2 (SCB2)	latched		
0	1	1	1	Short Circuit across load (SCL)	latched		
1	0	0	0	Short Circuit to Battery at disabled output	latched		
1	0	0	1	Short Circuit to Ground at disabled output	latched		
1	0	1	0	Open Load (at disabled output or in active)	latched		
1	0	1	1				
1	1	0	0	Netwood			
1	1	0	1	Not used			
1	1	1	0				
1	1	1	1	No failure	-		

Any read process of the error information (OL, OT, SCG1, SCG2, SCB1, SCB2, SCL) does not reset this information or register.

The errors can be reset selectively. By writing STATCON\_REG.DIACLR2 = 0, this resets all errors in DIA\_REG2, that is the previous errors. By writing STATCON REG.DIACLR1 = 0, this transfers all latched errors from DIA\_REG1 to DIA\_REG2 and resets DIA\_REG1 afterwards, if no undervoltage condition is present.

To fully reset the error logs, the following sequence has to be transmitted via SPI:

- STATCON\_REG.DIACLR1 = 0
- STATCON\_REG.DIACLR2 = 0

OT is the previously error from DIA\_REG1.

CurrRed and CurrLim represent the latched information. Each read process of DIA\_REG2 resets this error information. This error information is updated in case the error conditions reappear or are still present.



#### 3.2.7.6.3 Data register (read and write access)

			Table 36	6. Register CONFIG_F	REG						
Bit	7	6	5	4	3	2	1	0			
Bit-Name	FW	MUX	SDIR	SPWM	CL1	CL2	RESET	OLDA			
POR	1	1	1	1	1	0	1	0			
SPIR	1	1	1	1	1	0	1	0			
ENDISR	x	х	x	x	x	х	1	х			
DISR	x	х	x	x	x	х	x	х			
RDR	x	х	x	x	x	х	1	х			
Controller a	ccess	: read/w	rite	(write-access: WR_COM	NFIG)						
				(read-access: RD_CON	FIG)						
Bit		Name		Description							
7		FW	'1': free wheeling w	ith active short cut of body	/ diode	(latch	ed)				
1		1 00	'0': free wheeling or	: free wheeling only via body diode							
6		мих	'1': control by parall	el inputs PWM and DIR		(latch	ed)				
		MOX	'0': control by SPI b	'0': control by SPI bits SPWM and SDIR				(r/w)			
			Same effect like the	e signal DIR, but transmitte	ed via SPI						
5		SDIR	'0': same effect like	'0': same effect like DIR = Low				(latched)			
			'1': same effect like	'1': same effect like DIR = High				(r/w)			
			Same effect like the	e signal PWM, but transmi	tted via SPI						
4		SPWM	'0': same effect like	PWM = Low		(latch	ed)				
			'1': same effect like	PWM = High		(r/w)					
3		CL1	See Table 37 below	1		(latch	ed) (r/w)				
2		CL2				(					
1		RESET	'1': no change			(r/w)					
			'0': reset of device of	configuration to default							
0		OLDA	'1': Open Load diag	nosis in active operation	switched on	(latch	ed)				
Ŭ		02071	'0': Open Load diag	nosis in active operation	switched off	(r/w)	(r/w)				

#### Table 37. Current Level (CONFIG\_REG)

CL1	CL2	Description	Remark
0	0	No change	No change
0	1	2	5.0 A
1	0	3 (reset value)	6.6 A
1	1	4	8.6 A

#### Table 38. Register STATCON\_REG

Bit	7	6	5	4	3	2	1	0
Bit-Name	CONFIG2	CONFIG1	CONFIG0	DIACLR2	DIACLR1	STATUS2	STATUS1	STATUS0
POR	1	1	0	1	1	x	x	x
SPIR	1	1	0	1	1	х	x	х

Bit	7	6	5	4	3	2	1	0	
ENDISR	х	х	х	1	1	x	x	х	
DISR	x	x	x	x	x	x	x	x	
RDR	x	x	x	1	1	x	x	x	
Controlle	access: re	ead/write		(write-access: WI	R_STATCON)				
				(read-access: RD	_STATCON)				
Bit		Name			Description				
7	C	ONFIG2	'1': test of VD	D threshold is swite	ched off	(latched)			
	0	011102	'0': test of VD	D threshold is swite	ched on	(r/w)			
			'1': lower thre	shold of VDD-moni	toring is lifted	(latched)			
6	С	ONFIG1	(If CONFIG2	= 0 - test of switch-	off path)	()			
				eshold of VDD-mon	-	(r/w)			
				= 0 - test of switch-					
			'1': latch func switched on	tion for overvoltage	at VDD is	(latched)			
5	С	ONFIG0	'0': latch func switched off	'0': latch function for overvoltage at VDD is			(r/w)		
				previous errors of D	IA REG2 are				
			reset			(not latche	d)		
4	D	IACLR2	if set = 1: no	action		(r/w)			
			if read then a	lways = 1					
				all latched errors on all latched errors on all DIA_REG1 is re		be transfer	red to the r	egister	
3	D	IACLR1	Exception is: effect.	if an undervoltage	at pin V <sub>S</sub> is present	, DIACLR1 \	will not have	e any	
			if set = 1: no	action		(not latche	d)		
			if read then a	lways = 1		(r)			
2	S	TATUS2	Logic level at	NABE		(r)			
1	9	TATUS1	'1': no underv	voltage at VDD		(not latche	d)		
	0	AIUUT	'0': undervolt	age at VDD		(r)			
			'1': no overvo	ltage at VDD					
				ge at VDD resp. sta eset by CONFIG0 =		ge (r)			
0	S	TATUS0	= 0) will not b $V_S$ . Overvolta stored (CON at $V_S$ . The in	rervoltage information re reset by undervo age will even be det FIG0 = 1) during un formation will be res	ltage at ected and dervoltage set if an	SO			
			when CONFI	ervoltage at VDD) re G0 is set to 0 or via EG.RESET = 0).					

#### **Remarks:**

Write-access is only possible for CONFIGx and DIACLRx. The bits STATUSx are not affected by a write-access to STATCON\_REG, except indirectly by a change of CONFIGx.

Any write access to STATCON\_REG will take effect immediately. No re-enabling via switching (DIS to HIGH and then to LOW again) or (NABE via switching to Low and then to High again) is necessary.

Table 39	. Register	SPECIAL_	REG
----------	------------	----------	-----

Bit	7	6		5	4	3	2	1	0	
Bit-Name	Not specified	Not specified	DCr	natching	OLDAFILTER	Not specified	SR0	SR1	Reserved	
POR	0	0		0	1	0	0	0	1	
SPIR	0	0		0	1	0	0	0	1	
ENDISR	х	х		x	x	x	x	х	x	
DISR	х	х		х	x	x	x	x	x	
RDR	х	х		х	x	x	x	х	x	
Controller	access: read/	write			(write-access: WR	SPECIAL)				
					(read-access: RD_	SPECIAL)				
Bit		Name				Description				
7	No	t specified								
6	No	t specified								
5		Cmatching		'0': EMC optimized switching behavior						
5		Smatching		'1': exact duty cycle matching				(latched) (r/w)		
4	01	DAFILTER		'1': Open Load in on state detected after one retry				(latched) (r/w)		
-		DATIETER		'0': Open L	oad in on detected af	ter 40 ms				
3	No	t specified								
2		SR0		See Table 4			(latch	ed) (r/		
1		SR1					(เสเติ		vv j	
0	F	Reserved		r/w for spec	cial use		(latched) (r/w)			

#### Table 40. Slew Rate bits (SPECIAL\_REG)

SR1	SR0	Description	Remark
0	0	Slow slew rate	Default slew rate <sup>(1)</sup>
0	1	Fast slew rate	Fast slew rate <sup>(1)</sup>
1	0	Very fast slew rate 1	Very fact claw rate(1)
1	1	Very fast slew rate 2	Very fast slew rate <sup>(1)</sup>

1. See Section 3.2.4.3 Power stage switching parameters

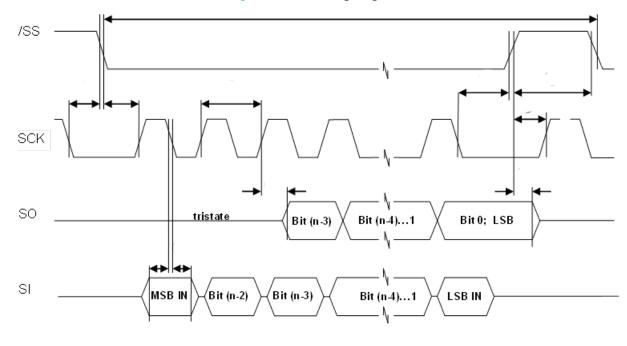
#### 3.2.7.7 Electrical characteristics

The timing of the H-bridge is defined as follows:

- The change at output (SO) is forced by the rising edge of the SCK signal.
- The input signal (SI) is latched on the falling edge of the SCK signal.
- The data received during a write access are written into the internal registers at the rising edge of the NSS signal, if exactly 16 SPI clock pulses have been counted during NSS = active.
- The data transmitted during a read access is reflecting the status of the chip just before the SPI read instruction.
- There is only a SPI communication with a clock; without clock, the H-bridge should not react on SO.



Figure 30. SPI Timing diagrams



r⊨16

All parameters at VDD: 4.4 V to 5.6 V. Battery supply V<sub>S</sub> is as specified in Section 2.6 Power Supply. Test condition: 2 V bias, 1 MHz, 20 mV (peak to peak) magnitude.

#### Table 41. SPI parameters

Symbol	Parameter	Condition	Min	Тур	Max	Unit
		Pin SI, SCK				
VSI_L	input low level	-	-0.3	-	0.8	V
VSI_H	input high level	-	2.0	-	VDD + 0.3	V
VSI_HYS	input hysteresis	-	0.15	-	1.0	V
I <sub>puSI</sub>	Pullup current	V <sub>SI</sub> = 0 V	20	40	60	μA
C <sub>SI</sub>	Input capacity	-	-	-	10	pF
	Chi	p addressing bonding pad				
VCA_L	input low level	-	-0.3	-	0.8	V
VCA_H	input high level	-	2.0	-	VDD + 0.3	V
I <sub>puSCK</sub>	Pullup current	V <sub>SCK</sub> = 0 V	20	40	60	μA
C <sub>SCK</sub>	Input capacity	-	-	-	10	pF
		Pin NSS				
VSS_L	input low level	-	-0.3	-	0.8	V
VSS_H	input high level	-	2.0	-	VDD + 0.3	V
VSS_HYS	input hysteresis	-	0.15	-	1.0	V
I <sub>puSS</sub>	Pullup current	V <sub>NSSx</sub> =0V	20	40	60	μA
C <sub>SS</sub>	Input capacity	-	-	-	15	pF

### L9969x

Functional behavior in detail



Symbol	Parameter	Condition	Min	Тур	Max	Unit
		Pin SO				
-	Tristate output of the H-bridge. On active reset (VDD < VDD_POR) output SO is in tristate) In case of small current, resistive behavior can be assumed	-	-	-	-	-
VSO_L	output low level	I_SO = 2 mA	0.0	-	0.4	V
VSO_H	output high level	I_SO = -2 mA	VDD -0.5	-	VDD	V
		C <sub>L</sub> = 25 pF	8		22	
t <sub>rf</sub>	Rise/fall times (10% to 90%)	C <sub>L</sub> = 100 pF	20	-	50	ns
		C <sub>L</sub> = 200 pF	38		82	
I <sub>SO</sub>	Leakage current	0 < VSO < VDD	-10	-	10	μA
I <sub>SO</sub>	Leakage current	VDD < VSO < 18 V SO in tri- state mode	600	800	1000	μA
C <sub>SO</sub>	Capacity of SO in tristate	-	-	-	10	pF
	Disturbanc	e of SPI interface				
∆Vx_L ∆Vx_H	Change of input low or high level of SPI input pins in case of inverse current on ${\rm V}_{\rm S}$	-	-0.1	-	0.1	V
∆I <sub>Sx</sub>	Change of input current of SPI input pins in case of inverse current on $V_S$	-	-100	-	100	μA
$\Delta I_{SO}$	Change of leakage current of SPI output pin in case of inverse current on $\mathrm{V}_\mathrm{S}$	-	-100	-	100	μA

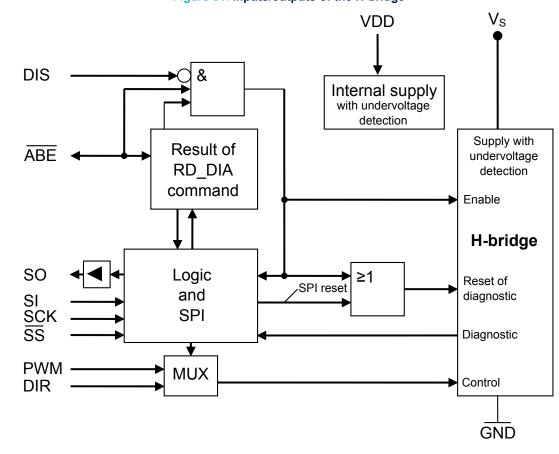
#### Table 42. SPI timing parameters

Symbol	Parameter	Condition	Min	Тур	Max	Unit
f <sub>s</sub>	Baud Rate	-	-	-	2	Mbit/s
t <sub>cyc</sub>	1 - Cycle Time (referred to master)	-	490	-	-	ns
t <sub>lead</sub>	2 - Enable Lead Time (referred to master)	-	50	-	-	ns
t <sub>lag</sub>	3 - Enable Lag Time (referred to master)	-	150	-	-	ns
		C <sub>L</sub> = 25 pF			90	
t <sub>v</sub>	4 - Data Valid (referred to master)	C <sub>L</sub> = 100 pF	-	-	110	ns
		C <sub>L</sub> = 200 pF			150	
t <sub>su</sub>	5 - Data Setup Time (referred to master)	-	40	-	-	ns
t <sub>h</sub>	6 - Data Hold Time (referred to master)	-	40	-	-	ns
t <sub>dis</sub>	7 - Disable Time (referred to the H-bridge)	-	-	-	100	ns
t <sub>dt</sub>	8 - Transfer Delay (referred to master)	-	250	-	-	ns
t <sub>dld</sub>	9 - Disable Lead Time (referred to master)	-	250	-	-	ns
t <sub>dlg</sub>	10 - Disable Lag Time (referred to master)	-	250	-	-	ns
t <sub>acc</sub>	11 - Access Time (referred to master)	-	8.35	-	-	μs



#### 3.2.7.8 Logic inputs and outputs





Note: • Both NABE and DIS release the power stages.

VDD monitoring sets NABE  $\rightarrow$  low, in case VDD is out of the operational range.

#### 3.2.7.8.1 Logic I/O electrical characteristics

#### Table 43. Logic I/O electrical characteristics

Symbol	Parameter	Condition	Min	Тур	Мах	Unit
	Pin DIR, PWM					
VINx_L	input low level	-	-0.3	-	0.8	V
VINx_H	input high level	-	2.0	-	VDD + 0.3	V
VINx_HYS	input hysteresis	-	0.15	-	1.0	V
I <sub>pulNx</sub>	Pullup current	V <sub>INx</sub> = 0 V	20	40	60	μA
I <sub>INx</sub>	input current VINx > 3.0 V (without Pull Up)	-	-5	-	+5	μA
C <sub>INx</sub>	Input capacity	-	-	-	20	pF
	Pin DIS	·				
VDIS_L	input low level	-	-0.3	-	0.8	V
VDIS_H	input high level	-	2.0	-	VDD + 0.3	V
VDIS_HYS	input hysteresis	-	0.15	-	1.0	V
I <sub>PUDIS</sub>	Pullup current	0 V < V <sub>DISx</sub> < 2.1 V	50	100	150	μA

Symbol	Parameter	Condition	Min	Тур	Мах	Unit
I <sub>DISx</sub>	input current VDIS > 3.0 V (without Pull Up)	-	-5	-	5	μA
C <sub>DIS</sub>	Input capacity	-	-	-	20	pF
t <sub>DIS</sub>	DIS pulse width pin DIS requires min. low level pulse width for setting/resetting SPI bits or diagnostic information	-	0.5	1	1.5	μs
	Disturbance of input pir	1				
∆Vx_L ∆Vx_H	Change of input low or high level of input pins in case of inverse current on ${\rm V}_{\rm S}$	-	-0.1	-	0.1	V
Δlx	Change of input low or high level of input pins in case of inverse current on $V_S$	-	-100	-	100	μA

#### 3.2.7.9 TEST pin

TEST pin is a high-voltage-driven input, exclusively used to provide one of the mandatory conditions in order to enter IC factory test-mode; externally providing a minimum required voltage value to TEST pin is not enough to successfully enter IC test-mode, as many other software conditions have to be met as well.

TEST pin input circuitry is provided with an internal resistive pull-down path to AGNDx ground, ensuring that input buffer does not provide wrong/uncertain information to the logic section in case TEST pin is left floating; thus, in ECU normal operation scenario, TEST pin can be either left open or connected to AGNDx ground (suggested implementation).

#### Table 44. TEST pin electrical characteristics

	Symbol	Parameter	Condition	Min	Тур	Max	Unit	Pin
VTE	EST_NOTM_MAX	TEST pin maximum allowed voltage in order to avoid IC test-mode activation	-	9	-	-	V	TEST

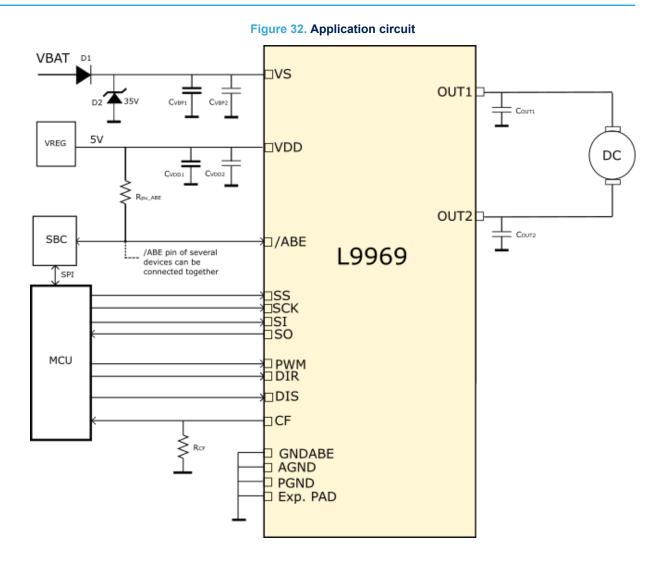


# 4 Functional safety

L9969 is developed as a safety element out of context (SEooC) according ISO 26262-5 development process. For more detailed information refer to the L9969 safety manual.



# 5 Application circuit





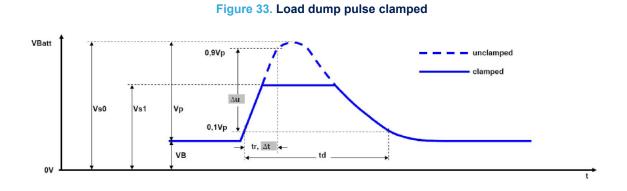
### 5.1 Bill Of Materials

Component	Min	Тур	Max	Unit	Requirement	Comment
C <sub>VBP1</sub>	-	100	-	μF	-	50 V
C <sub>VBP2</sub>	-	1	-	μF	To be mounted close to pin	-
C <sub>VDD1</sub>	-	10	-	μF	-	50 V
C <sub>VDD2</sub>	-	100	-	nF	To be mounted close to pin	-
C <sub>OUT1</sub>	10	-	33	nF	To be mounted close to pin	Values as big as possible (max 33 nF) are recommended if Open Load in OFF detection is disturbed
C <sub>OUT2</sub>	10	-	33	nF	To be mounted close to pin	Values as big as possible (max 33 nF) are recommended if Open Load in OFF detection is disturbed
R <sub>CF</sub>	-	5.1	-	kΩ	-	-
R <sub>pu_ABE</sub>	-	1	30	kΩ	-	-
D1	-	-	-	-	STPS5L60S	-
D2	-	-	-	-	SMA6T33AY	Clamp max: 35 V

#### Table 45. Bill Of Materials



# 6 Load dump pulse



#### Table 46. Load dump pulse parameters

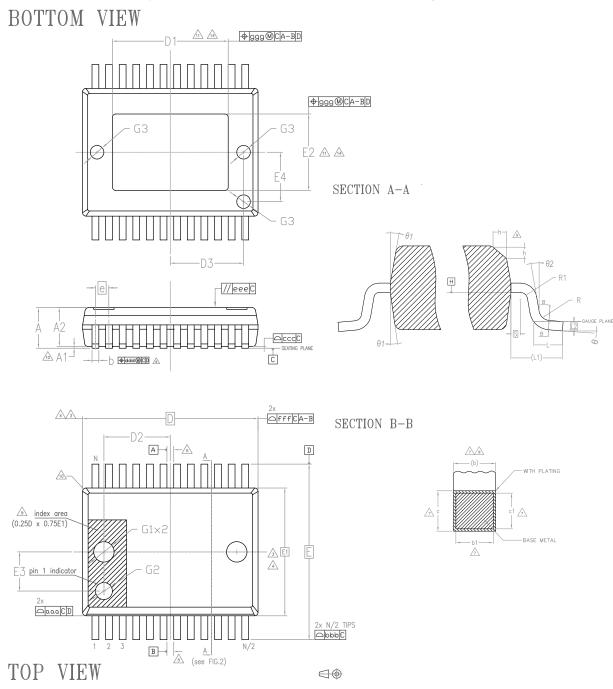
Parameter	Value	Tolerance	Test condition	Remark
VB	14.0 V	-		UBAT, nominal
Vsp0	101 V	-		Unclamped
Vp	87.0 V	-		Pulse-peak
Vs1	40.0 V	-		Clamped
Ri≤	0.5 Ω	-	Tamb: RT and 85 °C ±3 °C	-
Δu/Δt	7.0 V/ms	-		Vp/tr
Tr	10 ms	-5 ms		-
Td	400 ms	-	-	Pulse duration
То	60 s	-		Pulse periode
N	15	-		Number of pulses



# 7 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK packages, depending on their level of environmental compliance. ECOPACK specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

### 7.1 PowerSSO24 (exposed pad opt. A) package information



#### Figure 34. PowerSSO24 (exposed pad opt. A) package outline

Def	Dimensions (mm)					
Ref	Min.	Тур.	Max.			
θ	0°	-	8°			
Θ1	5°	-	10°			
Θ2	0°	-	-			
А	-	-	2.45			
A1	0.0	-	0.1			
A2	2.15	-	2.35			
b	0.33	-	0.51			
b1	0.28	0.40	0.48			
С	0.23	-	0.32			
c1	0.20	0.20	0.30			
D <sup>(1)</sup>		10.30 BSC				
D1		VARIATION				
D2	-	3.65	-			
D3	-	4.30	-			
е		0.80 BSC				
E		10.30 BSC				
E1 <sup>(1)</sup>		7.50 BSC				
E2		VARIATION				
E3	-	2.30	-			
E4	-	2.90	-			
G1	-	1.20	-			
G2	-	1.0	-			
G3	-	0.80	-			
h	0.30	-	0.40			
L	0.55	0.70	0.85			
L1		1.40 REF				
L2		0.25 BSC				
Ν		24 (# lead)				
R	0.30	-	-			
R1	0.20	-	-			
S	0.25	-	-			
	Tolerance of t	form and position				
ааа		0.20				
bbb	0.20					
ССС	0.10					
ddd	0.20					
eee	0.10					
ffff		0.20				
999		0.15				

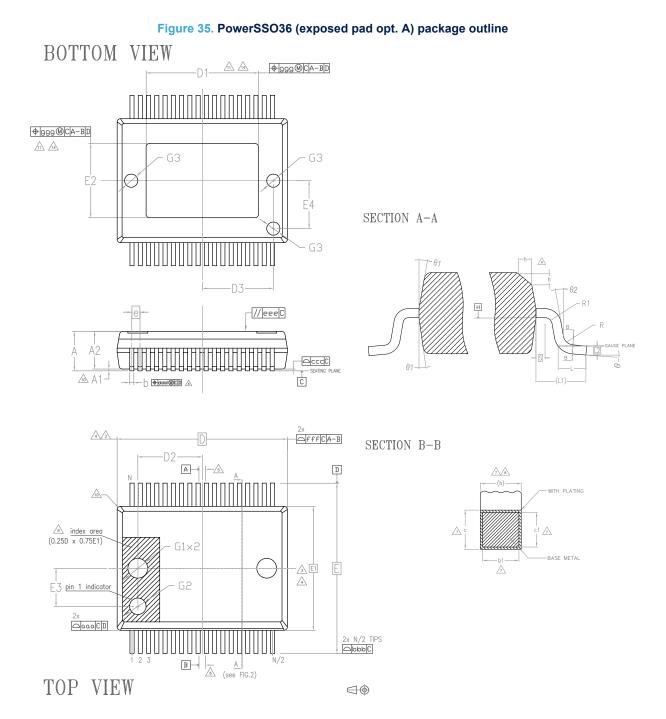
#### Table 47. PowerSSO24 (exposed pad opt. A) package mechanical data



Ref	Dimensions (mm)					
	Min.	Тур.	Max.			
	Ор	tion A				
D1	6.5	-	7.1			
E2	4.1	-	4.7			

1. Dimensions D and E1 do not include mold flash or protrusions. Allowable mold flash or protrusions is '0.25 mm' per side D and '0.15 mm' per side E1. D and E1 are Maximum plastic body size dimensions including mold mismatch.

## 7.2 PowerSSO36 (exposed pad opt. A) package information



Def					
Ref –	Min.	Тур.	Max.		
θ	0°	-	8°		
θ1	5°	-	10°		
θ2	0°	-	-		
A	2.15	-	2.45		
A1	0.0	-	0.1		
A2	2.15	-	2.35		
b	0.18	-	0.32		
b1	0.13	0.25	0.3		
С	0.23	-	0.32		
c1	0.2	0.2	0.3		
D <sup>(1)</sup>		10.30 BSC			
D1		VARIATION			
D2	-	3.65	-		
D3	-	4.3	-		
e		0.50 BSC			
E		10.30 BSC			
E1 <sup>(1)</sup>		7.50 BSC			
E2		VARIATION			
E3	-	2.3	-		
E4	-	2.9	-		
G1	-	1.2	-		
G2	-	1	-		
G3	-	0.8	-		
h	0.3	-	0.4		
L	0.55	0.7	0.85		
L1		1.40 REF			
L2		0.25 BSC			
N		36			
R	0.3	-	-		
R1	0.2	-	-		
S	0.25	-	-		
	Tolerance of	of form and position			
aaa	0.2				
bbb	0.2				
ccc	0.1				
ddd	0.2				
eee		0.1			
ffff		0.2			
		0.15			

0.15

#### Table 48. PowerSSO36 (exposed pad opt. A) package mechanical data

ggg



#### L9969x PowerSSO36 (exposed pad opt. A) package information

Ref	Dimensions (mm)					
	Min.	Тур.	Max.			
	Ор	tion A				
D1	6.5	-	7.1			
E2	4.1	-	4.7			

1. Dimensions D and E1 do not include mold flash or protrusions. Allowable mold flash or protrusions is '0.25 mm' per side D and '0.15 mm' per side E1. D and E1 are Maximum plastic body size dimensions including mold mismatch.

# **Revision history**

#### Table 49. Document revision history

Date	Version	Changes
13-Oct-2022	1	Initial release.
10-Nov-2022	2	To improve readability Figure 1. L9969S/L9969U single bridge IC block diagram and Figure 2. L9969T twin bridge IC block diagram have been updated. Added product status links on cover page.
16-Nov-2022	3	Updated: • Figure 1. L9969S/L9969U single bridge IC block diagram; • Figure 2. L9969T twin bridge IC block diagram.
08-May-2023	4	Updated Section Features in cover page. Updated Section 4 Functional safety. Minor text changes.



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